

## ISOLATED CAN TRANSCEIVER

Check for Samples: [ISO1050](#)

### FEATURES

- Meets the Requirements of ISO11898-2
- 5000- $V_{RMS}$  Isolation (ISO1050DW)
- 2500- $V_{RMS}$  Isolation (ISO1050DUB)
- Failsafe Outputs
- Low Loop Delay: 150ns (Typ), 210ns (Max)
- 50 kV/ $\mu$ s Typical Transient Immunity
- Bus-Fault Protection of –27 V to 40 V
- Driver (TXD) Dominant Time Out Function
- IEC 60747-5-2 (VDE 0884, Rev. 2) and IEC 61010-1 Approved
- UL 1577 Double Protection Approved; See Regulatory Information Section
- IEC 60601-1 (Medical) and CSA Approved
- 5 KV $_{RMS}$  Reinforced Insulation per TUV Approved for EN/UL/CSA 60950-1 (ISO1050DW)

- I/O Voltage Range Supports 3.3V and 5V Microprocessors
- Typical 25-Year Life at Rated Working Voltage (see Application Report [SLLA197](#) and [Figure 18](#))

### APPLICATIONS

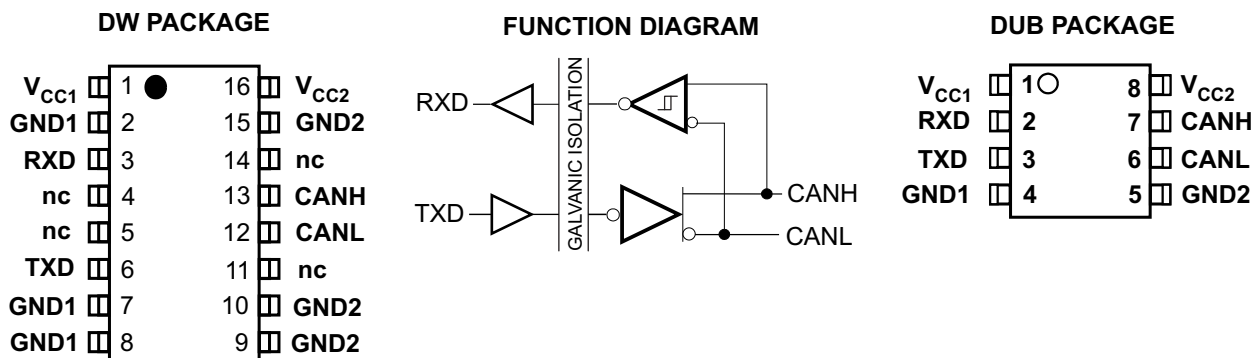
- Industrial Automation, Control, Sensors and Drive Systems
- Building and Climate Control (HVAC) Automation
- Security Systems
- Transportation
- Medical
- Telecom
- CAN Bus Standards Such as CANopen, DeviceNet, NMEA2000, ARINC825, ISO11783, CAN Kingdom, CANaerospace

### DESCRIPTION

The ISO1050 is a galvanically isolated CAN transceiver that meets the specifications of the ISO11898-2 standard. The device has the logic input and output buffers separated by a silicon oxide ( $SiO_2$ ) insulation barrier that provides galvanic isolation of up to 5000  $V_{RMS}$  for ISO1050DW and 2500  $V_{RMS}$  for ISO1050DUB. Used in conjunction with isolated power supplies, the device prevents noise currents on a data bus or other circuits from entering the local ground and interfering with or damaging sensitive circuitry.

As a CAN transceiver, the device provides differential transmit capability to the bus and differential receive capability to a CAN controller at signaling rates up to 1 megabit per second (Mbps). Designed for operation in especially harsh environments, the device features cross-wire, overvoltage and loss of ground protection from –27 V to 40 V and over-temperature shut-down, as well as –12 V to 12 V common-mode range.

The ISO1050 is characterized for operation over the ambient temperature range of –55°C to 105°C.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### AVAILABLE OPTIONS

| PRODUCT    | RATED ISOLATION       | PACKAGE | MARKED AS | ORDERING NUMBER    |
|------------|-----------------------|---------|-----------|--------------------|
| ISO1050DUB | 2500 V <sub>RMS</sub> | DUB-8   | ISO1050   | ISO1050DUB (rail)  |
|            |                       |         |           | ISO1050DUBR (reel) |
| ISO1050DW  | 5000 V <sub>RMS</sub> | DW-16   | ISO1050   | ISO1050DW (rail)   |
|            |                       |         |           | ISO1050DWR (reel)  |

### PIN FUNCTIONS

| PIN              |         |     | TYPE   | DESCRIPTION                                                                  |
|------------------|---------|-----|--------|------------------------------------------------------------------------------|
| NAME             | PACKAGE |     |        |                                                                              |
|                  | DW      | DUB |        |                                                                              |
| V <sub>CC1</sub> | 1       | 1   | Supply | Digital side supply voltage (3 to 5.5V)                                      |
| GND1             | 2       | NA  | GND1   | Digital side ground connection                                               |
| RXD              | 3       | 2   | O      | CAN receive data output (LOW for dominant and HIGH for recessive bus states) |
| NC               | 4       | NA  | NC     | No connect                                                                   |
| NC               | 5       | NA  | NC     | No connect                                                                   |
| TXD              | 6       | 3   | I      | CAN transmit data input (LOW for dominant and HIGH for recessive bus states) |
| GND1             | 7       | 4   | GND1   | Digital side ground connection                                               |
| GND1             | 8       | NA  | GND1   | Digital side ground connection                                               |
| GND2             | 9       | 5   | GND2   | Transceiver side ground connection                                           |
| GND2             | 10      | NA  | GND2   | Transceiver side ground connection                                           |
| NC               | 11      | NA  | NC     | No connect                                                                   |
| CANL             | 12      | 6   | I/O    | Low level CAN bus line                                                       |
| CANH             | 13      | 7   | I/O    | High level CAN bus line                                                      |
| NC               | 14      | NA  | NC     | No connect                                                                   |
| GND2             | 15      | NA  | GND2   | Transceiver side ground connection                                           |
| V <sub>CC2</sub> | 16      | 8   | Supply | Transceiver side supply voltage (5V)                                         |

## FUNCTIONAL DESCRIPTION

### CAN BUS STATES

The CAN bus has two states during operation: *dominant* and *recessive*. A dominant bus state, equivalent to logic low, is when the bus is driven differentially by a driver. A recessive bus state is when the bus is biased to a common mode of  $V_{CC} / 2$  via the high-resistance internal input resistors of the receiver, equivalent to a logic high. The host microprocessor of the CAN node will use the TXD pin to drive the bus and will receive data from the bus on the RXD pin. See [Figure 1](#) and [Figure 2](#).

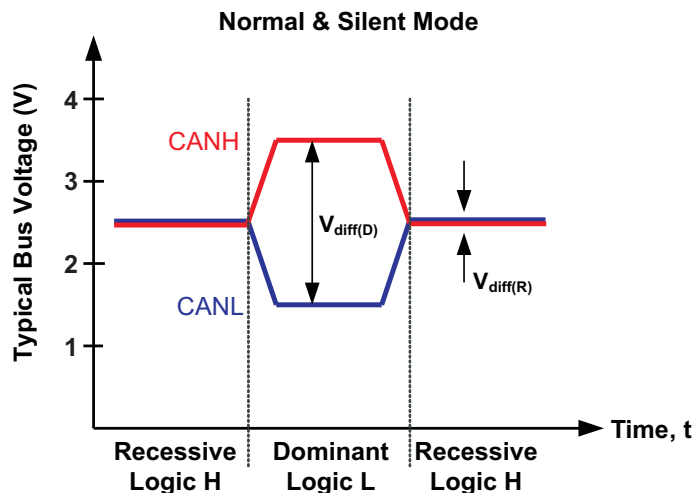


Figure 1. Bus States (Physical Bit Representation)

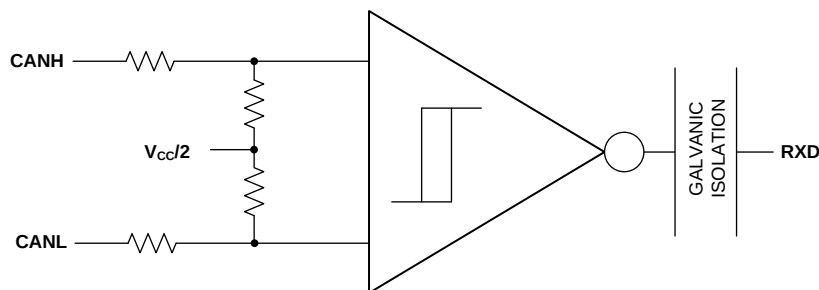


Figure 2. Simplified Recessive Common Mode Bias and Receiver

## DRIVER AND RECEIVER FUNCTION TABLES

**Table 1. Driver Function Table**

| INPUT              | OUTPUTS             |                     | DRIVEN BUS STATE |
|--------------------|---------------------|---------------------|------------------|
|                    | CANH <sup>(1)</sup> | CANL <sup>(1)</sup> |                  |
| TXD <sup>(1)</sup> |                     |                     |                  |
| L                  | H                   | L                   | Dominant         |
| H                  | Z                   | Z                   | Recessive        |

(1) H = high level, L = low level, Z = common mode (recessive) bias to  $V_{CC} / 2$ . See Figure 1 and Figure 2 for bus state and common mode bias information.

**Table 2. Receiver Function Table**

| DEVICE MODE      | CAN DIFFERENTIAL INPUTS<br>$V_{ID} = V_{CANH} - V_{CANL}$ | BUS STATE | RXD PIN <sup>(1)</sup> |
|------------------|-----------------------------------------------------------|-----------|------------------------|
| Normal or Silent | $V_{ID} \geq 0.9 \text{ V}$                               | Dominant  | L                      |
|                  | $0.5 \text{ V} < V_{ID} < 0.9 \text{ V}$                  | ?         | ?                      |
|                  | $V_{ID} \leq 0.5 \text{ V}$                               | Recessive | H                      |
|                  | Open ( $V_{ID} \approx 0 \text{ V}$ )                     | Open      | H                      |

(1) H = high level, L = low level, ? = indeterminate.

## DIGITAL INPUTS AND OUTPUTS

### TXD (Input) and RXD (Output):

$V_{CC1}$  for the isolated digital input and output side of the device maybe supplied by a 3.3 V or 5 V supply and thus the digital inputs and outputs are 3.3 V and 5 V compatible.

#### NOTE

TXD is very weakly internally pulled up to  $V_{CC1}$ . An external pull up resistor should be used to make sure that TXD is biased to recessive (high) level to avoid issues on the bus if the microprocessor doesn't control the pin and TXD floats. TXD pullup strength and CAN bit timing require special consideration when the device is used with an open-drain TXD output on the microprocessor's CAN controller. An adequate external pullup resistor must be used to ensure that the TXD output of the microprocessor maintains adequate bit timing input to the input on the transceiver.

## PROTECTION FEATURES

### TXD Dominant Timeout (DTO)

TXD DTO circuit prevents the local node from blocking network communication in the event of a hardware or software failure where TXD is held dominant longer than the timeout period  $t_{TXD\_DTO}$ . The TXD DTO circuit timer starts on a falling edge on TXD. The TXD DTO circuit disables the CAN bus driver if no rising edge is seen before the timeout period expires. This frees the bus for communication between other nodes on the network. The CAN driver is re-activated when a recessive signal is seen on the TXD pin, thus clearing the TXD DTO condition. The receiver and RXD pin still reflect the CAN bus, and the bus pins are biased to recessive level during a TXD dominant timeout.

#### NOTE

The minimum dominant TXD time allowed by the TXD DTO circuit limits the minimum possible transmitted data rate of the device. The CAN protocol allows a maximum of eleven successive dominant bits (on TXD) for the worst case, where five successive dominant bits are followed immediately by an error frame. This, along with the  $t_{TXD\_DTO}$  minimum, limits the minimum data rate. Calculate the minimum transmitted data rate by:  
Minimum Data Rate =  $11 / t_{TXD\_DTO}$ .

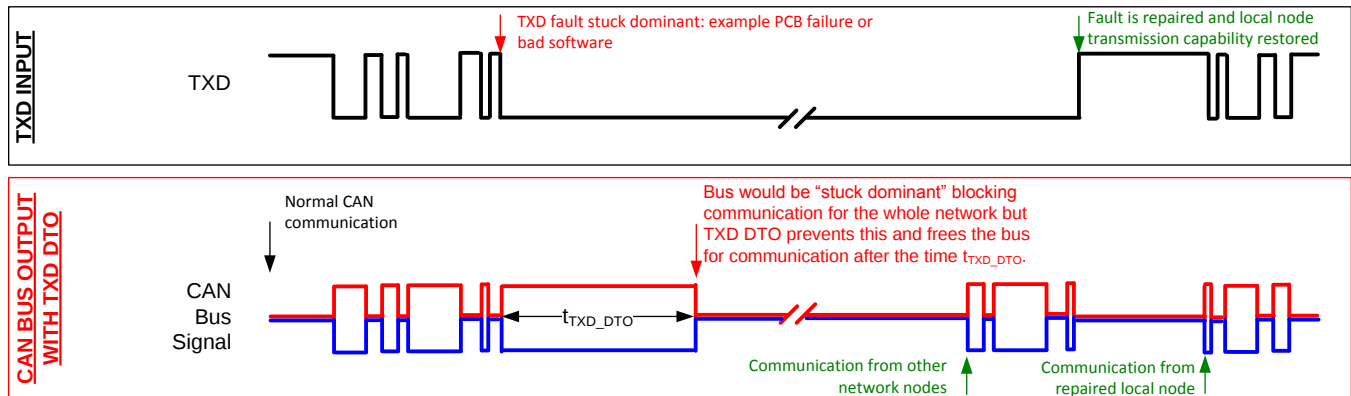


Figure 3. Example Timing Diagram for Devices With TXD DTO

## Thermal Shutdown

If the junction temperature of the device exceeds the thermal shut down threshold the device turns off the CAN driver circuits thus blocking the TXD to bus transmission path. The shutdown condition is cleared when the junction temperature drops below the thermal shutdown temperature of the device. If the fault condition is still present, the temperature may rise again and the device would enter thermal shut down again. Prolonged operation with thermal shutdown conditions may affect device reliability.

### NOTE

During thermal shutdown the CAN bus drivers turn off; thus no transmission is possible from TXD to the bus. The CAN bus pins are biased to recessive level during a thermal shutdown, and the receiver to RXD path remains operational.

## Undervoltage Lockout and Failsafe

The supply pins have undervoltage detection that places the device in protected or failsafe mode. This protects the bus during an undervoltage event on  $V_{CC1}$  or  $V_{CC2}$  supply pins. If the bus-side power supply  $V_{CC2}$  is lower than about 2.7V, the power shutdown circuits in the ISO1050 will disable the transceiver to prevent false transmissions due to an unstable supply. If  $V_{CC1}$  is still active when this occurs, the receiver output (RXD) will go to a failsafe HIGH (recessive) value in about 6 microseconds.

Table 3. Undervoltage Lockout and Failsafe

| $V_{CC1}$ | $V_{CC2}$ | DEVICE STATE | BUS OUTPUT               | RXD                       |
|-----------|-----------|--------------|--------------------------|---------------------------|
| GOOD      | GOOD      | Functional   | Per Device State and TXD | Mirrors Bus               |
| BAD       | GOOD      | Protected    | Recessive                | High Impedance (3-state)  |
| GOOD      | BAD       | Protected    | High Impedance           | Recessive (Failsafe High) |

### NOTE

After an undervoltage condition is cleared and the supplies have returned to valid levels, the device typically resumes normal operation in 300  $\mu$ s

## Floating Pins

Pull ups and pull downs should be used on critical pins to place the device into known states if the pins float. The TXD pin should be pulled up via a resistor to  $V_{CC1}$  to force a recessive input level if the microprocessor output to the pin floats.

## CAN Bus Short Circuit Current Limiting

The device has several protection features that limit the short circuit current when a CAN bus line is shorted. These include driver current limiting (dominant and recessive). The device has TXD dominant state time out to prevent permanent higher short circuit current of the dominant state during a system fault. During CAN communication the bus switches between dominant and recessive states with the data and control fields bits, thus the short circuit current may be viewed either as the instantaneous current during each bus state, or as a DC average current. For system current (power supply) and power considerations in the termination resistors and common-mode choke ratings, use the average short circuit current. Determine the ratio of dominant and recessive bits by the data in the CAN frame plus the following factors of the protocol and PHY that force either recessive or dominant at certain times:

- Control fields with set bits
- Bit stuffing
- Interframe space
- TXD dominant time out (fault case limiting)

These ensure a minimum recessive amount of time on the bus even if the data field contains a high percentage of dominant bits.

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### NOTE

The short circuit current of the bus depends on the ratio of recessive to dominant bits and their respective short circuit currents. The average short circuit current may be calculated with the following formula:

$$I_{OS(AVG)} = \%Transmit \times [(\%REC\_Bits \times I_{OS(SS)\_REC}) + (\%DOM\_Bits \times I_{OS(SS)\_DOM})] + [\%Receive \times I_{OS(SS)\_REC}]$$

Where

- $I_{OS(AVG)}$  is the average short circuit current
  - $\%Transmit$  is the percentage the node is transmitting CAN messages
  - $\%Receive$  is the percentage the node is receiving CAN messages
  - $\%REC\_Bits$  is the percentage of recessive bits in the transmitted CAN messages
  - $\%DOM\_Bits$  is the percentage of dominant bits in the transmitted CAN messages
  - $I_{OS(SS)\_REC}$  is the recessive steady state short circuit current
  - $I_{OS(SS)\_DOM}$  is the dominant steady state short circuit current
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### NOTE

Consider the short circuit current and possible fault cases of the network when sizing the power ratings of the termination resistance and other network components.

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**ABSOLUTE MAXIMUM RATINGS<sup>(1) (2)</sup>**

|                                        |                                                |                                     |                                  | VALUE / UNIT   |
|----------------------------------------|------------------------------------------------|-------------------------------------|----------------------------------|----------------|
| V <sub>CC1</sub> , V <sub>CC2</sub>    | Supply voltage <sup>(3)</sup>                  |                                     |                                  | –0.5 V to 6 V  |
| V <sub>I</sub>                         | Voltage input (TXD)                            |                                     |                                  | –0.5 V to 6 V  |
| V <sub>CANH</sub> or V <sub>CANL</sub> | Voltage range at any bus terminal (CANH, CANL) |                                     |                                  | –27 V to 40 V  |
| I <sub>O</sub>                         | Receiver output current                        |                                     |                                  | ±15 mA         |
| ESD                                    | Human Body Model                               | JEDEC Standard 22, Method A114-C.01 | Bus pins and GND2 <sup>(4)</sup> | ±4 kV          |
|                                        |                                                |                                     | All pins                         | ±4 kV          |
|                                        | Charged Device Model                           | JEDEC Standard 22, Test Method C101 | All pins                         | ±1.5 kV        |
|                                        | Machine Model                                  | ANSI/ESDS5.2-1996                   | All pins                         | ±200 V         |
| T <sub>stg</sub>                       | Storage temperature                            |                                     |                                  | –65°C to 150°C |
| T <sub>J</sub>                         | Junction temperature                           |                                     |                                  | –55°C to 150°C |

- (1) Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under *recommended operating conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) This isolator is suitable for basic isolation within the safety limiting data. Maintenance of the safety data must be ensured by means of protective circuitry.
- (3) All input and output logic voltage values are measured with respect to the GND1 logic side ground. Differential bus-side voltages are measured to the respective bus-side GND2 ground terminal.
- (4) Tested while connected between V<sub>CC2</sub> and GND2.

**RECOMMENDED OPERATING CONDITIONS**

|                                   |                                                    |          | MIN                | NOM | MAX  | UNIT |
|-----------------------------------|----------------------------------------------------|----------|--------------------|-----|------|------|
| V <sub>CC1</sub>                  | Supply voltage, controller side                    |          | 3                  |     | 5.5  | V    |
| V <sub>CC2</sub>                  | Supply voltage, bus side                           |          | 4.75               | 5   | 5.25 | V    |
| V <sub>I</sub> or V <sub>IC</sub> | Voltage at bus pins (separately or common mode)    |          | –12 <sup>(1)</sup> |     | 12   | V    |
| V <sub>IH</sub>                   | High-level input voltage                           | TXD      | 2                  |     | 5.25 | V    |
| V <sub>IL</sub>                   | Low-level input voltage                            | TXD      | 0                  |     | 0.8  | V    |
| V <sub>ID</sub>                   | Differential input voltage                         |          | –7                 |     | 7    | V    |
| I <sub>OH</sub>                   | High-level output current                          | Driver   | –70                |     |      | mA   |
|                                   |                                                    | Receiver | –4                 |     |      |      |
| I <sub>OL</sub>                   | Low-level output current                           | Driver   |                    |     | 70   | mA   |
|                                   |                                                    | Receiver |                    |     | 4    |      |
| T <sub>A</sub>                    | Ambient Temperature                                |          | –55                |     | 105  | °C   |
| T <sub>J</sub>                    | Junction temperature (see THERMAL CHARACTERISTICS) |          | –55                |     | 125  | °C   |

- (1) The algebraic convention, in which the least positive (most negative) limit is designated as minimum is used in this data sheet.

**SUPPLY CURRENT**

over recommended operating conditions (unless otherwise noted)

| PARAMETER        |                                 |           | TEST CONDITIONS                                                    |  | MIN | TYP <sup>(1)</sup> | MAX | UNIT |
|------------------|---------------------------------|-----------|--------------------------------------------------------------------|--|-----|--------------------|-----|------|
| I <sub>CC1</sub> | V <sub>CC1</sub> Supply current |           | V <sub>I</sub> = 0 V or V <sub>CC1</sub> , V <sub>CC1</sub> = 3.3V |  |     | 1.8                | 2.8 | mA   |
|                  |                                 |           | V <sub>I</sub> = 0 V or V <sub>CC1</sub> , V <sub>CC1</sub> = 5V   |  |     | 2.3                | 3.6 |      |
| I <sub>CC2</sub> | V <sub>CC2</sub> Supply current | Dominant  | V <sub>I</sub> = 0 V, 60-Ω Load                                    |  |     | 52                 | 73  | mA   |
|                  |                                 | Recessive | V <sub>I</sub> = V <sub>CC1</sub>                                  |  |     | 8                  | 12  |      |

- (1) All typical values are at 25°C with V<sub>CC1</sub> = V<sub>CC2</sub> = 5V.

## DEVICE SWITCHING CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

| PARAMETER   |                                                                          | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-------------|--------------------------------------------------------------------------|-----------------|-----|-----|-----|------|
| $t_{loop1}$ | Total loop delay, driver input to receiver output, Recessive to Dominant | See Figure 12   | 112 | 150 | 210 | ns   |
| $t_{loop2}$ | Total loop delay, driver input to receiver output, Dominant to Recessive | See Figure 12   | 112 | 150 | 210 | ns   |

## DRIVER ELECTRICAL CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

| PARAMETER    |                                           | TEST CONDITIONS                                                                                      | MIN   | TYP  | MAX   | UNIT              |
|--------------|-------------------------------------------|------------------------------------------------------------------------------------------------------|-------|------|-------|-------------------|
| $V_{O(D)}$   | Bus output voltage (Dominant)             | See Figure 4 and Figure 5, $V_I = 0\text{ V}$ , $R_L = 60\Omega$                                     | 2.9   | 3.5  | 4.5   | V                 |
|              |                                           |                                                                                                      | 0.8   | 1.2  | 1.5   |                   |
| $V_{O(R)}$   | Bus output voltage (Recessive)            | See Figure 4 and Figure 5, $V_I = 2\text{ V}$ , $R_L = 60\Omega$                                     | 2     | 2.3  | 3     | V                 |
| $V_{OD(D)}$  | Differential output voltage (Dominant)    | See Figure 4, Figure 5 and Figure 6, $V_I = 0\text{ V}$ , $R_L = 60\Omega$                           | 1.5   |      | 3     | V                 |
|              |                                           | See Figure 4, Figure 5, and Figure 6 $V_I = 0\text{ V}$ , $R_L = 45\Omega$ , $V_{CC} > 4.8\text{ V}$ | 1.4   |      | 3     |                   |
| $V_{OD(R)}$  | Differential output voltage (Recessive)   | See Figure 4 and Figure 5, $V_I = 3\text{ V}$ , $R_L = 60\Omega$                                     | -0.12 |      | 0.012 | V                 |
|              |                                           | $V_I = 3\text{ V}$ , No Load                                                                         | -0.5  |      | 0.05  |                   |
| $V_{OC(D)}$  | Common-mode output voltage (Dominant)     | See Figure 11                                                                                        | 2     | 2.3  | 3     | V                 |
| $V_{OC(pp)}$ | Peak-to-peak common-mode output voltage   |                                                                                                      |       | 0.3  |       |                   |
| $I_{IH}$     | High-level input current, TXD input       | $V_I$ at 2 V                                                                                         |       |      | 5     | $\mu\text{A}$     |
| $I_{IL}$     | Low-level input current, TXD input        | $V_I$ at 0.8 V                                                                                       | -5    |      |       | $\mu\text{A}$     |
| $I_{O(off)}$ | Power-off TXD leakage current             | $V_{CC1}$ , $V_{CC2}$ at 0 V, TXD at 5 V                                                             |       |      | 10    | $\mu\text{A}$     |
| $I_{OS(ss)}$ | Short-circuit steady-state output current | See Figure 14, $V_{CANH} = -12\text{ V}$ , CANL Open                                                 | -105  | -72  |       | mA                |
|              |                                           | See Figure 14, $V_{CANH} = 12\text{ V}$ , CANL Open                                                  |       | 0.36 | 1     |                   |
|              |                                           | See Figure 14, $V_{CANL} = -12\text{ V}$ , CANH Open                                                 | -1    | -0.5 |       |                   |
|              |                                           | See Figure 14, $V_{CANL} = 12\text{ V}$ , CANH Open                                                  |       | 71   | 105   |                   |
| $C_O$        | Output capacitance                        | See receiver input capacitance                                                                       |       |      |       |                   |
| CMTI         | Common-mode transient immunity            | See Figure 16, $V_I = V_{CC}$ or 0 V                                                                 | 25    | 50   |       | kV/ $\mu\text{s}$ |

## DRIVER SWITCHING CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

| PARAMETER       |                                                      | TEST CONDITIONS                                  | MIN | TYP | MAX | UNIT          |
|-----------------|------------------------------------------------------|--------------------------------------------------|-----|-----|-----|---------------|
| $t_{PLH}$       | Propagation delay time, recessive-to-dominant output | See Figure 7                                     | 31  | 74  | 110 | ns            |
| $t_{PHL}$       | Propagation delay time, dominant-to-recessive output |                                                  | 25  | 44  | 75  |               |
| $t_r$           | Differential output signal rise time                 |                                                  |     | 20  | 50  |               |
| $t_f$           | Differential output signal fall time                 |                                                  |     | 20  | 50  |               |
| $t_{dom}^{(1)}$ | Dominant time-out                                    | $\downarrow C_L = 100\text{ pF}$ , See Figure 13 | 300 | 450 | 700 | $\mu\text{s}$ |

- (1) The TXD dominant time out ( $t_{dom}$ ) disables the driver of the transceiver once the TXD has been dominant longer than ( $t_{dom}$ ) which releases the bus lines to recessive preventing a local failure from locking the bus dominant. The driver may only transmit dominant again after TXD has been returned HIGH (recessive). While this protects the bus from local faults locking the bus dominant it limits the minimum data rate possible. The CAN protocol allows a maximum of eleven successive dominant bits (on TXD) for the worst case where five successive dominant bits are followed immediately by an error frame. This along with the ( $t_{dom}$ ) minimum limits the minimum bit rate. The minimum bit rate may be calculated by: Minimum Bit Rate =  $11 / (t_{dom}) = 11\text{ bits} / 300\text{ }\mu\text{s} = 37\text{ kbps}$ .

## RECEIVER ELECTRICAL CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

| PARAMETER                                                                                                      | TEST CONDITIONS                                                        | MIN                   | TYP <sup>(1)</sup> | MAX | UNIT  |
|----------------------------------------------------------------------------------------------------------------|------------------------------------------------------------------------|-----------------------|--------------------|-----|-------|
| V <sub>IT+</sub> Positive-going bus input threshold voltage                                                    | See <a href="#">Table 4</a>                                            |                       | 750                | 900 | mV    |
| V <sub>IT-</sub> Negative-going bus input threshold voltage                                                    |                                                                        | 500                   | 650                |     | mV    |
| V <sub>hys</sub> Hysteresis voltage (V <sub>IT+</sub> – V <sub>IT-</sub> )                                     |                                                                        |                       | 150                |     | mV    |
| V <sub>OH</sub> High-level output voltage with V <sub>CC</sub> = 5V                                            | I <sub>OH</sub> = –4 mA, See <a href="#">Figure 9</a>                  | V <sub>CC</sub> – 0.8 | 4.6                |     | V     |
|                                                                                                                | I <sub>OH</sub> = –20 µA, See <a href="#">Figure 9</a>                 | V <sub>CC</sub> – 0.1 | 5                  |     |       |
| V <sub>OH</sub> High-level output voltage with V <sub>CC1</sub> = 3.3V                                         | I <sub>OL</sub> = 4 mA, See <a href="#">Figure 9</a>                   | V <sub>CC</sub> – 0.8 | 3.1                |     | V     |
|                                                                                                                | I <sub>OL</sub> = 20 µA, See <a href="#">Figure 9</a>                  | V <sub>CC</sub> – 0.1 | 3.3                |     |       |
| V <sub>OL</sub> Low-level output voltage                                                                       | I <sub>OL</sub> = 4 mA, See <a href="#">Figure 9</a>                   |                       | 0.2                | 0.4 | V     |
|                                                                                                                | I <sub>OL</sub> = 20 µA, See <a href="#">Figure 9</a>                  |                       | 0                  | 0.1 |       |
| C <sub>I</sub> Input capacitance to ground, (CANH or CANL)                                                     | TXD at 3 V, V <sub>I</sub> = 0.4 sin (4E6πt) + 2.5V                    |                       | 6                  |     | pF    |
| C <sub>ID</sub> Differential input capacitance                                                                 | TXD at 3 V, V <sub>I</sub> = 0.4 sin (4E6πt)                           |                       | 3                  |     | pF    |
| R <sub>ID</sub> Differential input resistance                                                                  | TXD at 3 V                                                             | 30                    |                    | 80  | kΩ    |
| R <sub>IN</sub> Input resistance (CANH or CANL)                                                                | TXD at 3 V                                                             | 15                    | 30                 | 40  | kΩ    |
| R <sub>I(m)</sub> Input resistance matching<br>(1 – [R <sub>IN (CANH)</sub> / R <sub>IN (CANL)</sub> ]) × 100% | V <sub>CANH</sub> = V <sub>CANL</sub>                                  | –3%                   | 0%                 | 3%  |       |
| CMTI Common-mode transient immunity                                                                            | V <sub>I</sub> = V <sub>CC</sub> or 0 V, See <a href="#">Figure 16</a> | 25                    | 50                 |     | kV/µs |

(1) All typical values are at 25°C with V<sub>CC1</sub> = V<sub>CC2</sub> = 5V.

## RECEIVER SWITCHING CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

| PARAMETER                                                           | TEST CONDITIONS                                        | MIN | TYP | MAX | UNIT |
|---------------------------------------------------------------------|--------------------------------------------------------|-----|-----|-----|------|
| t <sub>PLH</sub> Propagation delay time, low-to-high-level output   | TXD at 3 V, See <a href="#">Figure 9</a>               | 66  | 90  | 130 | ns   |
| t <sub>PHL</sub> Propagation delay time, high-to-low-level output   |                                                        | 51  | 80  | 105 |      |
| t <sub>r</sub> Output signal rise time                              |                                                        |     | 3   | 6   |      |
| t <sub>f</sub> Output signal fall time                              |                                                        |     | 3   | 6   |      |
| t <sub>fs</sub> Failsafe output delay time from bus-side power loss | V <sub>CC1</sub> at 5 V, See <a href="#">Figure 15</a> |     | 6   |     | µs   |

## PARAMETER MEASUREMENT INFORMATION

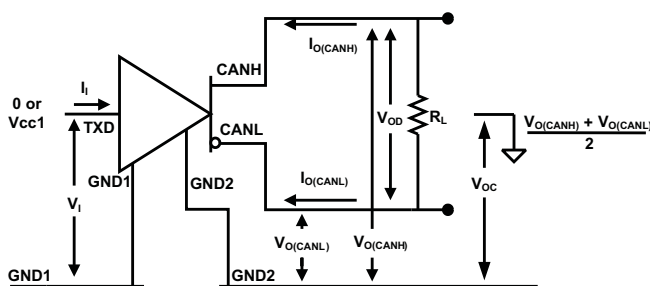


Figure 4. Driver Voltage, Current and Test Definitions

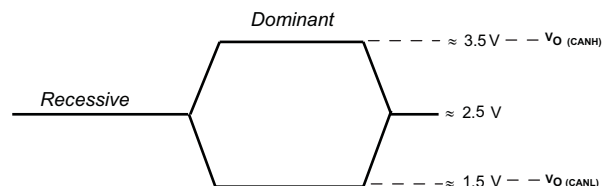


Figure 5. Bus Logic State Voltage Definitions

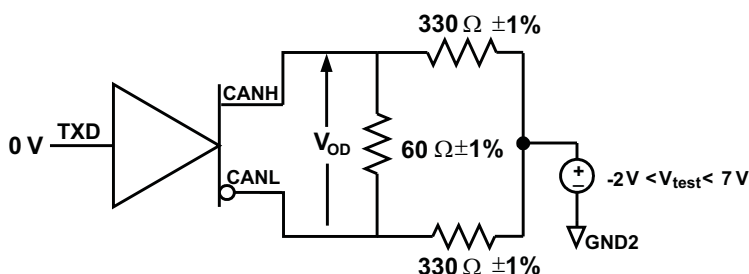
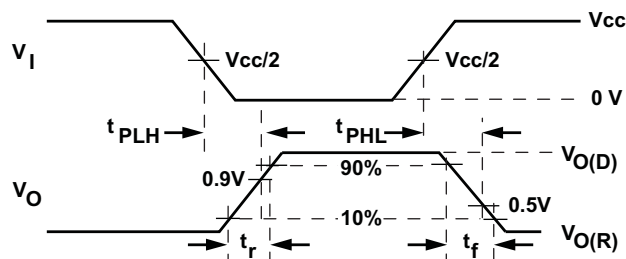
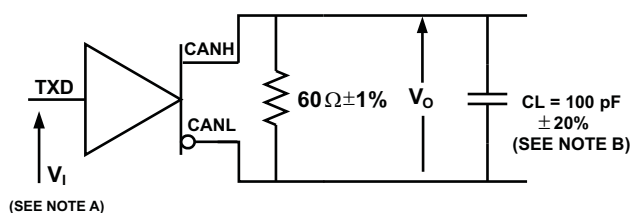


Figure 6. Driver  $V_{OD}$  with Common-mode Loading Test Circuit



- The input pulse is supplied by a generator having the following characteristics:  $PRR \leq 125 \text{ kHz}$ , 50% duty cycle,  $t_r \leq 6 \text{ ns}$ ,  $t_f \leq 6 \text{ ns}$ ,  $Z_O = 50\Omega$ .
- $C_L$  includes instrumentation and fixture capacitance within  $\pm 20\%$ .

Figure 7. Driver Test Circuit and Voltage Waveforms

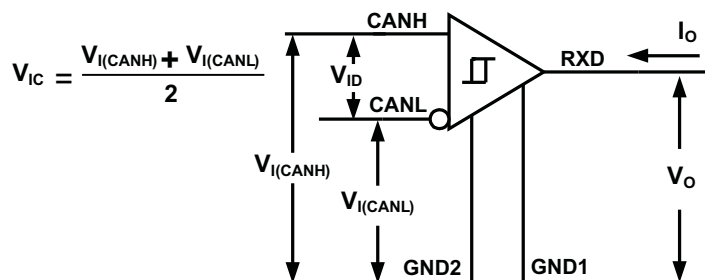
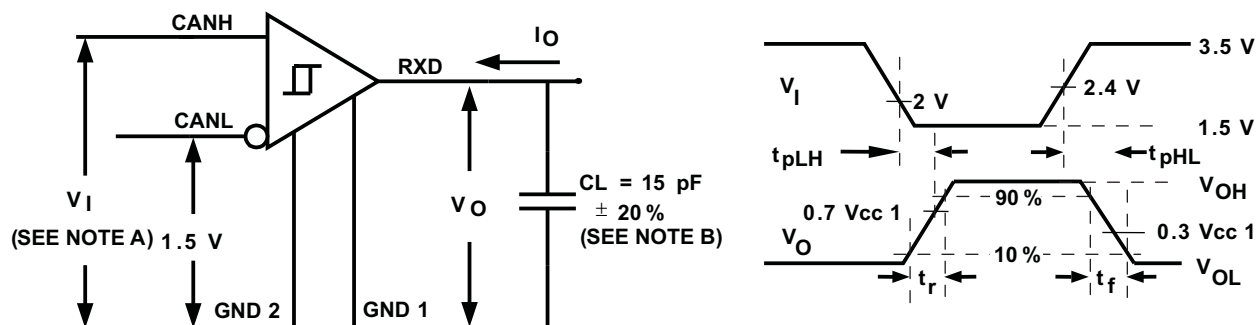


Figure 8. Receiver Voltage and Current Definitions

## PARAMETER MEASUREMENT INFORMATION (continued)

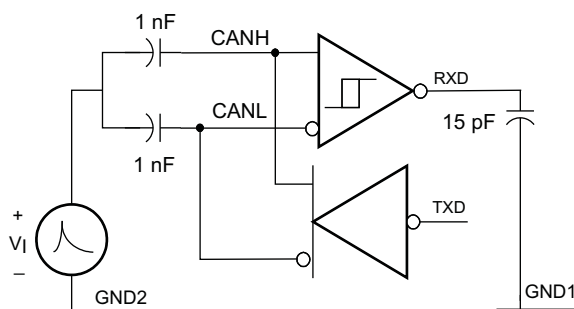


- A. The input pulse is supplied by a generator having the following characteristics: PRR  $\leq$  125 kHz, 50% duty cycle,  $t_r \leq 6$  ns,  $t_f \leq 6$  ns,  $Z_O = 50\Omega$ .
- B.  $C_L$  includes instrumentation and fixture capacitance within  $\pm 20\%$ .

Figure 9. Receiver Test Circuit and Voltage Waveforms

Table 4. Differential Input Voltage Threshold Test

| INPUT      |            |            | OUTPUT |          |
|------------|------------|------------|--------|----------|
| $V_{CANH}$ | $V_{CANL}$ | $ V_{ID} $ | R      |          |
| -11.1 V    | -12 V      | 900 mV     | L      | $V_{OL}$ |
| 12 V       | 11.1 V     | 900 mV     | L      |          |
| -6 V       | -12 V      | 6 V        | L      |          |
| 12 V       | 6 V        | 6 V        | L      |          |
| -11.5 V    | -12 V      | 500 mV     | H      | $V_{OH}$ |
| 12 V       | 11.5 V     | 500 mV     | H      |          |
| -12 V      | -6 V       | -6 V       | H      |          |
| 6 V        | 12 V       | -6 V       | H      |          |
| Open       | Open       | X          | H      |          |



The waveforms of the applied transients are in accordance with ISO 7637 part 1, test pulses 1, 2, 3a, and 3b.

Figure 10. Transient Over-Voltage Test Circuit

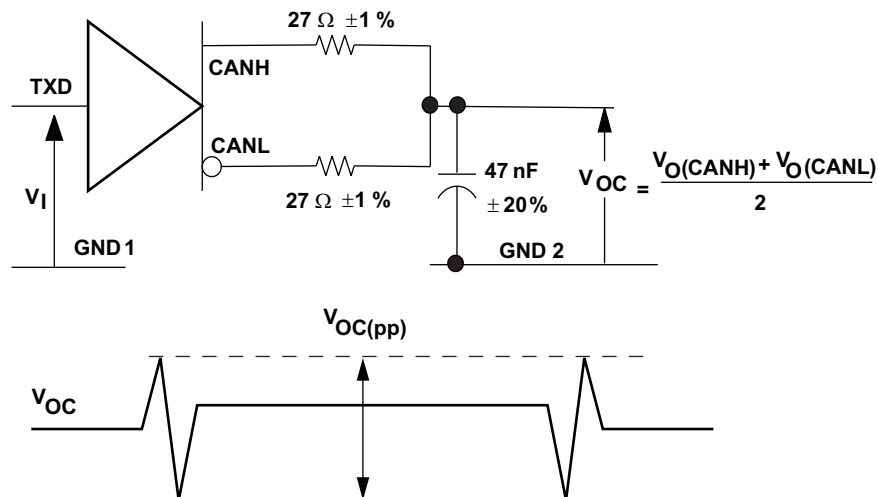
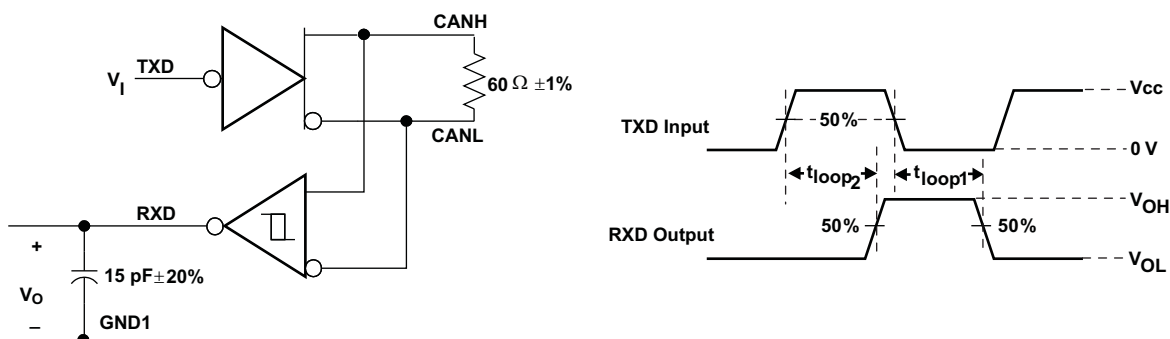
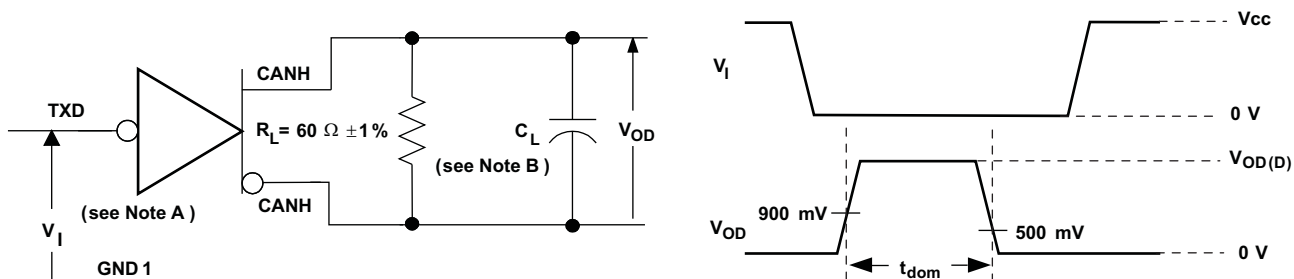


Figure 11. Peak-to-Peak Output Voltage Test Circuit and Waveform

Figure 12.  $t_{LOOP}$  Test Circuit and Voltage Waveforms

- A. The input pulse is supplied by a generator having the following characteristics:  $t_r \leq 6$  ns,  $t_f \leq 6$  ns,  $Z_O = 50\Omega$ .  
 B.  $C_L$  includes instrumentation and fixture capacitance within  $\pm 20\%$ .

Figure 13. Dominant Timeout Test Circuit and Voltage Waveforms

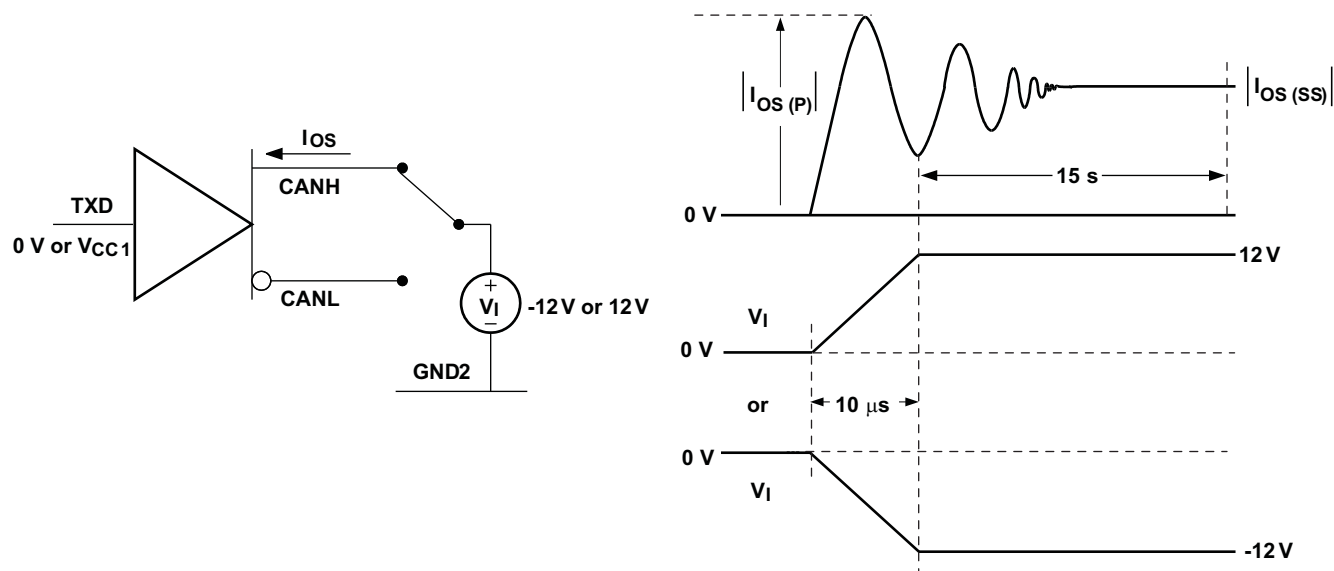


Figure 14. Driver Short-Circuit Current Test Circuit and Waveforms

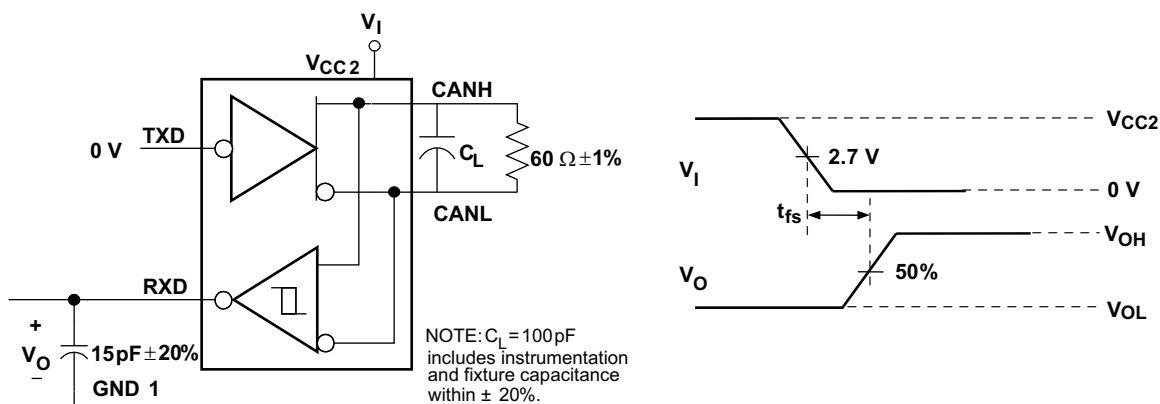


Figure 15. Failsafe Delay Time Test Circuit and Voltage Waveforms

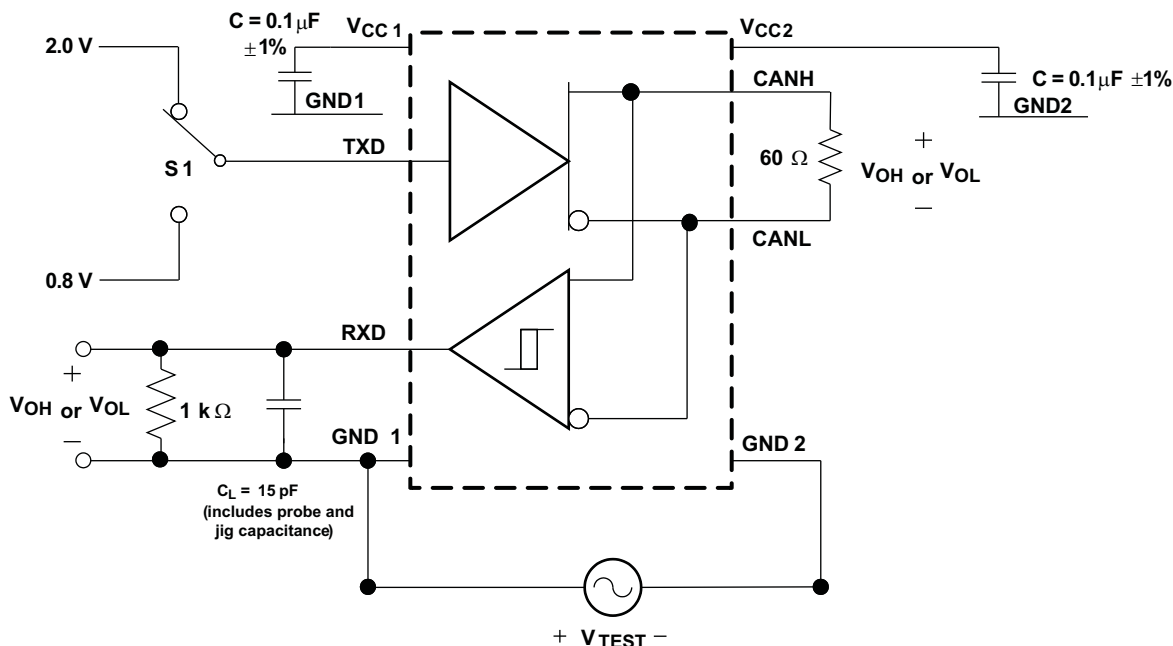


Figure 16. Common-Mode Transient Immunity Test Circuit

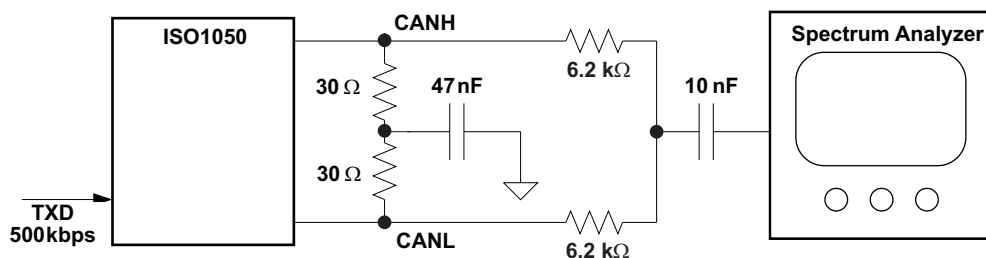


Figure 17. Electromagnetic Emissions Measurement Setup

## DEVICE INFORMATION

FUNCTION TABLE<sup>(1)</sup>

| DRIVER           |         |      |           | RECEIVER                                                    |               |           |
|------------------|---------|------|-----------|-------------------------------------------------------------|---------------|-----------|
| INPUTS           | OUTPUTS |      | BUS STATE | DIFFERENTIAL INPUTS<br>$V_{ID} = \text{CANH} - \text{CANL}$ | OUTPUT<br>RXD | BUS STATE |
| TXD              | CANH    | CANL |           |                                                             |               |           |
| L <sup>(2)</sup> | H       | L    | DOMINANT  | $V_{ID} \geq 0.9 \text{ V}$                                 | L             | DOMINANT  |
| H                | Z       | Z    | RECESSIVE | $0.5 \text{ V} < V_{ID} < 0.9 \text{ V}$                    | ?             | ?         |
| Open             | Z       | Z    | RECESSIVE | $V_{ID} \leq 0.5 \text{ V}$                                 | H             | RECESSIVE |
| X                | Z       | Z    | RECESSIVE | Open                                                        | H             | RECESSIVE |

(1) H = high level; L = low level; X = irrelevant; ? = indeterminate; Z = high impedance

(2) Logic low pulses to prevent dominant time-out.

## ISOLATOR CHARACTERISTICS <sup>(1) (2)</sup>

over recommended operating conditions (unless otherwise noted)

| PARAMETER       |                                           | TEST CONDITIONS                                                                                                                           | MIN               | TYP | MAX | UNIT |
|-----------------|-------------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------|-------------------|-----|-----|------|
| L(I01)          | Minimum air gap (Clearance)               | Shortest terminal to terminal distance through air                                                                                        | 6.1               |     |     | mm   |
| L(I02)          | Minimum external tracking (Creepage)      | Shortest terminal to terminal distance across the package surface                                                                         | 6.8               |     |     | mm   |
| L(I01)          | Minimum air gap (Clearance)               | Shortest terminal to terminal distance through air                                                                                        | 8.34              |     |     | mm   |
| L(I02)          | Minimum external tracking (Creepage)      | Shortest terminal to terminal distance across the package surface                                                                         | 8.10              |     |     | mm   |
|                 | Minimum Internal Gap (Internal Clearance) | Distance through the insulation                                                                                                           | 0.014             |     |     | mm   |
| R <sub>IO</sub> | Isolation resistance                      | Input to output, V <sub>IO</sub> = 500 V, all pins on each side of the barrier tied together creating a two-terminal device, Tamb < 100°C | >10 <sup>12</sup> |     |     | Ω    |
|                 |                                           | Input to output V <sub>IO</sub> = 500 V, 100°C ≤ Tamb ≤ Tamb max                                                                          | >10 <sup>11</sup> |     |     | Ω    |
| C <sub>IO</sub> | Barrier capacitance                       | V <sub>I</sub> = 0.4 sin (4E6πt)                                                                                                          |                   | 1.9 |     | pF   |
| C <sub>I</sub>  | Input capacitance to ground               | V <sub>I</sub> = 0.4 sin (4E6πt)                                                                                                          |                   | 1.3 |     | pF   |

- (1) Creepage and clearance requirements should be applied according to the specific equipment isolation standards of an application. Care should be taken to maintain the creepage and clearance distance of a board design to ensure that the mounting pads of the isolator on the printed circuit board do not reduce this distance.
- (2) Creepage and clearance on a printed circuit board become equal according to the measurement techniques shown in the Isolation Glossary. Techniques such as inserting grooves and/or ribs on a printed circuit board are used to help increase these specifications.

## INSULATION CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

| PARAMETER         |                                            | TEST CONDITIONS                           | SPECIFICATION     | UNIT  |
|-------------------|--------------------------------------------|-------------------------------------------|-------------------|-------|
| V <sub>IORM</sub> | Maximum working insulation voltage per IEC | ISO1050DUB                                | 560               | Vpeak |
|                   |                                            | ISO1050DW                                 | 1200              |       |
| V <sub>PR</sub>   | Input to output test voltage per IEC       | ISO1050DUB                                | 1050              | Vpeak |
|                   |                                            | ISO1050DW                                 | 2250              |       |
| V <sub>IOTM</sub> | Transient overvoltage per IEC              | t = 60 sec (qualification)                | 4000              | Vpeak |
|                   |                                            | t = 1 sec (100% production)               |                   |       |
| V <sub>ISO</sub>  | Isolation voltage per UL                   | ISO1050DUB                                | 2500              | Vrms  |
|                   |                                            | t = 1 sec (100% production)               | 3000              |       |
|                   |                                            | ISO1050DW                                 | 4243              | Vrms  |
|                   |                                            | t = 1 sec (100% production)               | 5092              |       |
| R <sub>S</sub>    | Isolation voltage per UL                   | V <sub>IO</sub> = 500 V at T <sub>S</sub> | > 10 <sup>9</sup> | Ω     |
|                   | Pollution Degree                           |                                           | 2                 |       |

## IEC 60664-1 RATINGS

| PARAMETER                   | TEST CONDITIONS                                 | SPECIFICATION |
|-----------------------------|-------------------------------------------------|---------------|
| Basic isolation group       | Material group                                  | II            |
| Installation classification | Rated mains voltage ≤ 150 Vrms                  | I–IV          |
|                             | Rated mains voltage ≤ 300 Vrms                  | I–III         |
|                             | Rated mains voltage ≤ 400 Vrms                  | I–II          |
|                             | Rated mains voltage ≤ 600 Vrms (ISO1050DW only) | I–II          |
|                             | Rated mains voltage ≤ 848 Vrms (ISO1050DW only) | I             |

## IEC SAFETY LIMITING VALUES

safety limiting intends to prevent potential damage to the isolation barrier upon failure of input or output circuitry. A failure of the IO can allow low resistance to ground or the supply and, without current limiting dissipate sufficient power to overheat the die and damage the isolation barrier potentially leading to secondary system failures.

| PARAMETER      |                                         | TEST CONDITIONS |                                                                                                                          | MIN | TYP | MAX | UNIT |
|----------------|-----------------------------------------|-----------------|--------------------------------------------------------------------------------------------------------------------------|-----|-----|-----|------|
| I <sub>S</sub> | Safety input, output, or supply current | DUB-8           | $\theta_{JA} = 73.3^{\circ}\text{C/W}$ , $V_I = 5.5\text{ V}$ , $T_J = 150^{\circ}\text{C}$ , $T_A = 25^{\circ}\text{C}$ |     |     | 310 | mA   |
|                |                                         |                 | $\theta_{JA} = 73.3^{\circ}\text{C/W}$ , $V_I = 3.6\text{ V}$ , $T_J = 150^{\circ}\text{C}$ , $T_A = 25^{\circ}\text{C}$ |     |     | 474 |      |
|                |                                         | DW-16           | $\theta_{JA} = 76^{\circ}\text{C/W}$ , $V_I = 5.5\text{ V}$ , $T_J = 150^{\circ}\text{C}$ , $T_A = 25^{\circ}\text{C}$   |     |     | 299 | mA   |
|                |                                         |                 | $\theta_{JA} = 76^{\circ}\text{C/W}$ , $V_I = 3.6\text{ V}$ , $T_J = 150^{\circ}\text{C}$ , $T_A = 25^{\circ}\text{C}$   |     |     | 457 |      |
| T <sub>S</sub> | Maximum case temperature                |                 |                                                                                                                          |     |     | 150 | °C   |

The safety-limiting constraint is the absolute maximum junction temperature specified in the absolute maximum ratings table. The power dissipation and junction-to-air thermal impedance of the device installed in the application hardware determines the junction temperature. The assured junction-to-air thermal resistance in the Thermal Characteristics table is that of a device installed on a High-K Test Board for Leadless Surface Mount Packages. The power is the recommended maximum input voltage times the current. The junction temperature is then the ambient temperature plus the power times the junction-to-air thermal resistance.

## REGULATORY INFORMATION

| VDE                                                                                                                                                                                                            | TUV                                                                                                                                                                                                                                                                                                                                                                                                                           | CSA                                                                                                                            | UL                                                                                                                                                               |
|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------------------------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Certified according to DIN EN 60747-5-2                                                                                                                                                                        | Certified according to EN/UL/CSA 60950-1                                                                                                                                                                                                                                                                                                                                                                                      | Approved under CSA Component Acceptance Notice #5A                                                                             | Recognized under 1577<br>(1)Component Recognition Program                                                                                                        |
| Basic Insulation<br>Transient Overvoltage, 4000 V <sub>PK</sub><br>Surge Voltage, 4000 V <sub>PK</sub><br>Maximum Working Voltage, 1200 V <sub>PK</sub><br>(ISO1050DW) and<br>560 V <sub>PK</sub> (ISO1050DUB) | <b>ISO1050DW:</b><br>5000 V <sub>RMS</sub> Reinforced Insulation,<br>400 V <sub>RMS</sub> maximum working voltage<br>5000 V <sub>RMS</sub> Basic Insulation,<br>600 V <sub>RMS</sub> maximum working voltage<br><b>ISO1050DUB:</b><br>2500 V <sub>RMS</sub> Reinforced Insulation,<br>400 V <sub>RMS</sub> maximum working voltage<br>2500 V <sub>RMS</sub> Basic Insulation,<br>600 V <sub>RMS</sub> maximum working voltage | 5000 V <sub>RMS</sub> Reinforced Insulation<br>2 Means of Patient Protection at 125 V <sub>RMS</sub> per IEC 60601-1 (3rd Ed.) | Double Protection<br>ISO1050DUB: 2500 V <sub>RMS</sub><br>ISO1050DW: 3500 V <sub>RMS</sub> ,<br>4243 V <sub>RMS</sub> Single Protection<br>Certification pending |
| File Number: 40016131                                                                                                                                                                                          | Certificate Number: U8V 11 09 77311 008                                                                                                                                                                                                                                                                                                                                                                                       | File Number: 220991                                                                                                            | File Number: E181974                                                                                                                                             |

(1) Production tested  $\geq 3000\text{ V}_{\text{RMS}}$  (ISO1050DUB) and 5092 V<sub>RMS</sub> (ISO1050DW) for 1 second in accordance with UL 1577.

## THERMAL INFORMATION (DUB-8 PACKAGE)

over recommended operating conditions (unless otherwise noted)

| PARAMETER               |                                             | TEST CONDITIONS                                                                                                                                   | MIN | TYP  | MAX | UNIT |
|-------------------------|---------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------------------|-----|------|-----|------|
| $\theta_{JA}$           | Junction-to-air                             | Low-K Thermal Resistance <sup>(1)</sup>                                                                                                           |     | 120  |     | °C/W |
|                         |                                             | High-K Thermal Resistance                                                                                                                         |     | 73.3 |     | °C/W |
| $\theta_{JB}$           | Junction-to-board thermal resistance        | Low-K Thermal Resistance                                                                                                                          |     | 10.2 |     | °C/W |
| $\theta_{JC}$           | Junction-to-case thermal resistance         | Low-K Thermal Resistance                                                                                                                          |     | 14.5 |     | °C/W |
| P <sub>D</sub>          | Device power dissipation                    | V <sub>CC1</sub> = 5.5V, V <sub>CC2</sub> = 5.25V, T <sub>A</sub> = 105°C, R <sub>L</sub> = 60Ω, TXD input is a 500kHz 50% duty-cycle square wave |     |      | 200 | mW   |
| T <sub>J</sub> shutdown | Thermal shutdown temperature <sup>(2)</sup> |                                                                                                                                                   |     | 190  |     | °C   |

(1) Tested in accordance with the Low-K or High-K thermal metric definitions of EIA/JESD51-3 for leadless surface mount packages.

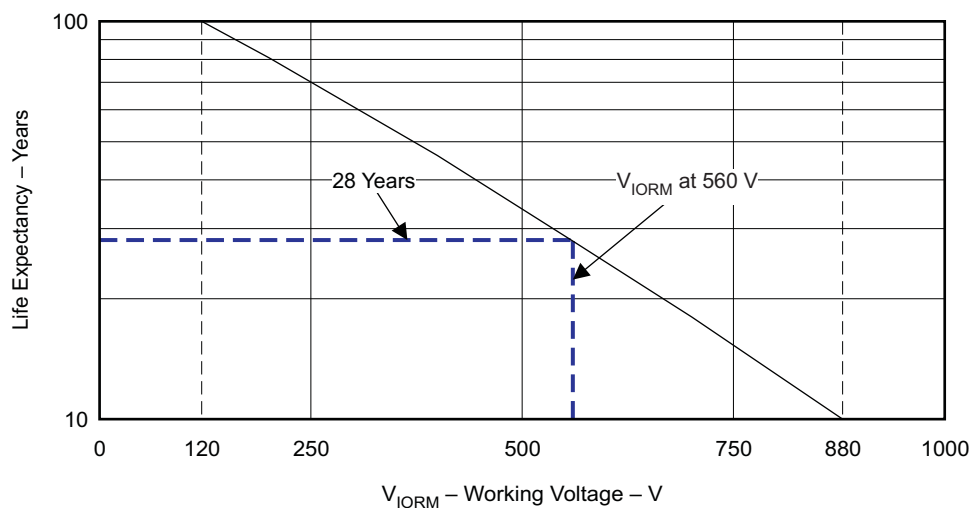
(2) Extended operation in thermal shutdown may affect device reliability.

## THERMAL INFORMATION (DW-16 PACKAGE)

| THERMAL METRIC <sup>(1)</sup> |                                              | ISO1050 | UNITS |
|-------------------------------|----------------------------------------------|---------|-------|
|                               |                                              | DW      |       |
|                               |                                              | 16      |       |
| $\theta_{JA}$                 | Junction-to-ambient thermal resistance       | 76.0    | °C/W  |
| $\theta_{JCTop}$              | Junction-to-case (top) thermal resistance    | 41      |       |
| $\theta_{JB}$                 | Junction-to-board thermal resistance         | 47.7    |       |
| $\Psi_{JT}$                   | Junction-to-top characterization parameter   | 14.4    |       |
| $\Psi_{JB}$                   | Junction-to-board characterization parameter | 38.2    |       |
| $\theta_{JCbott}$             | Junction-to-case (bottom) thermal resistance | n/a     |       |

(1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, [SPRA953](#).

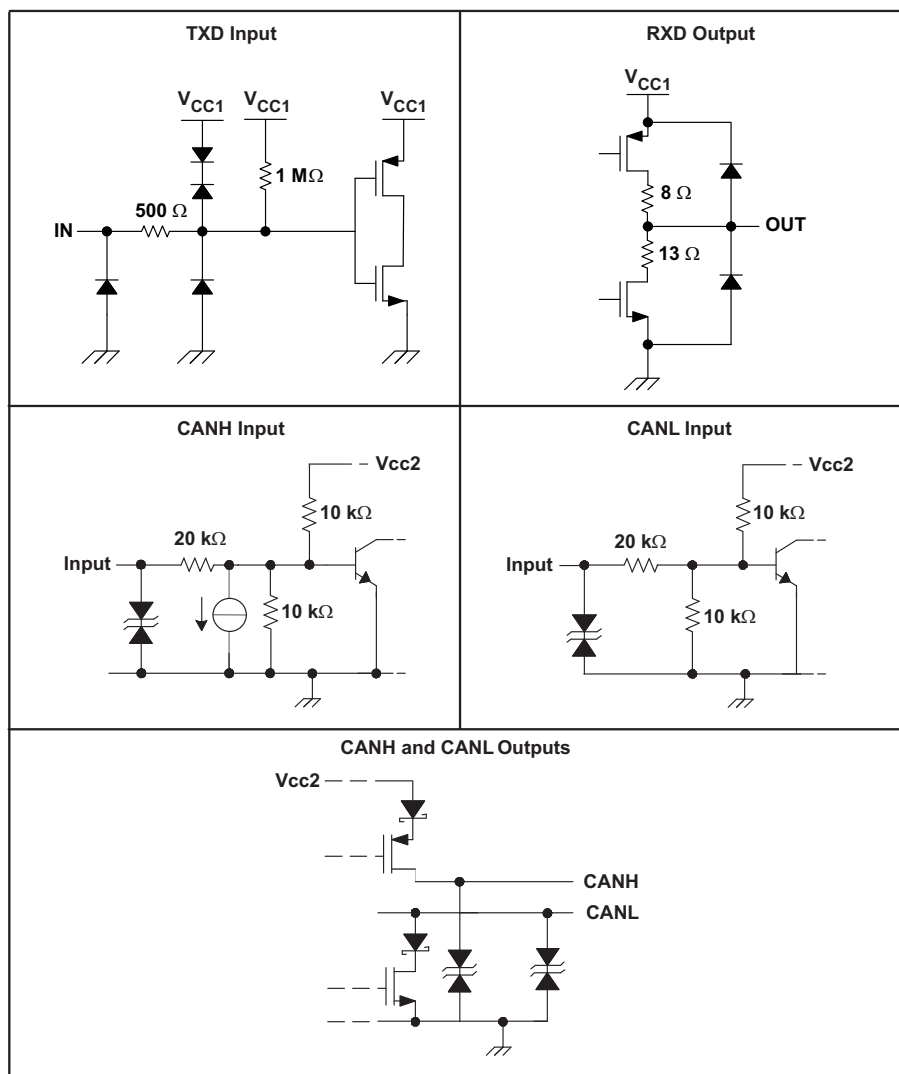
## LIFE EXPECTANCY vs WORKING VOLTAGE (ISO1050DW)



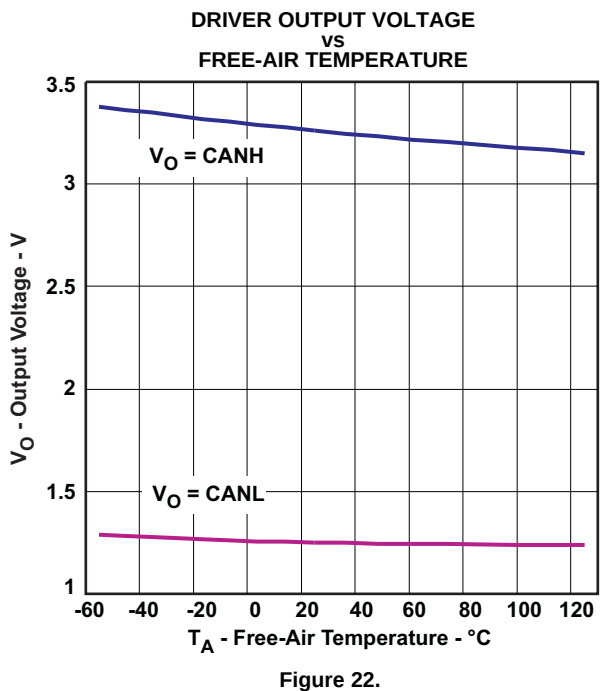
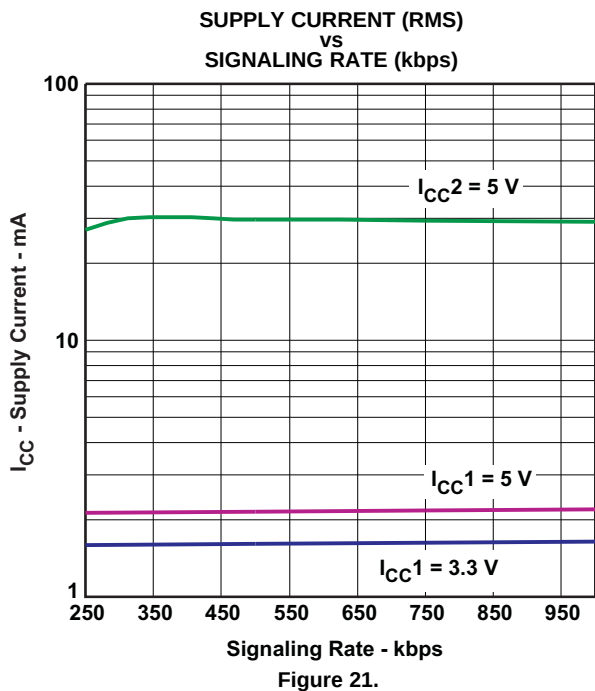
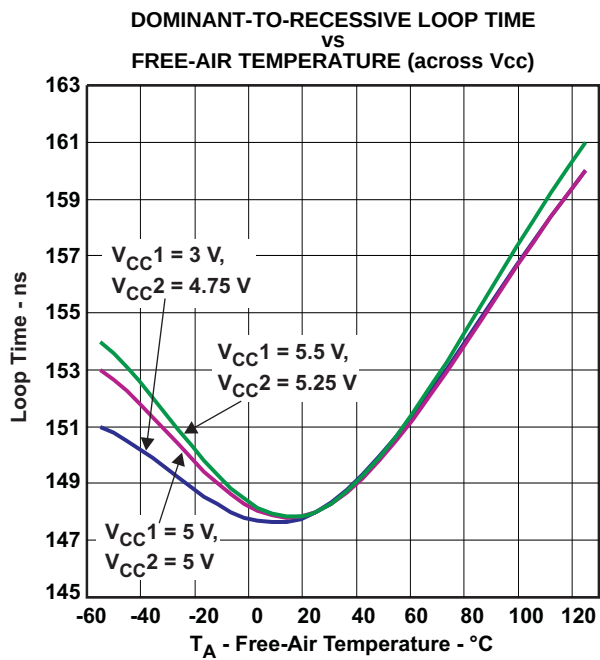
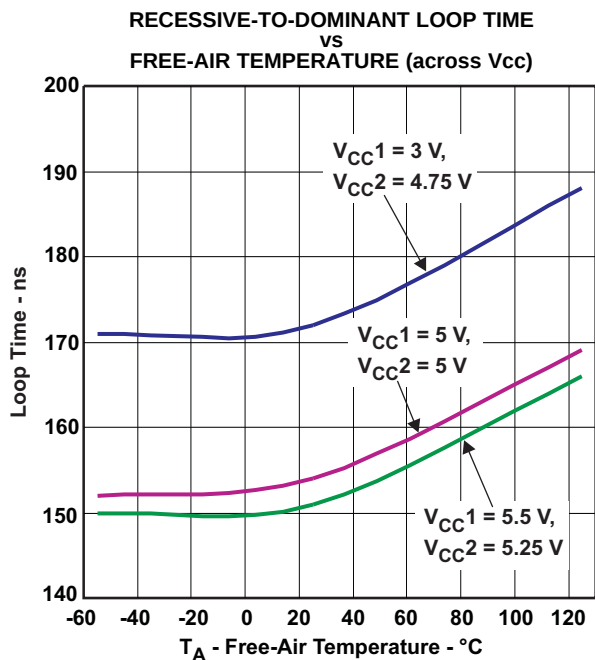
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**Figure 18. Life Expectancy vs Working Voltage**

## EQUIVALENT I/O SCHEMATICS

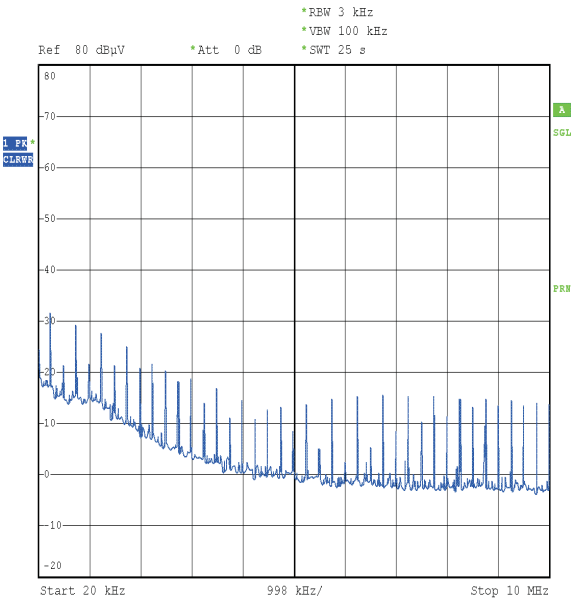


## TYPICAL CHARACTERISTICS



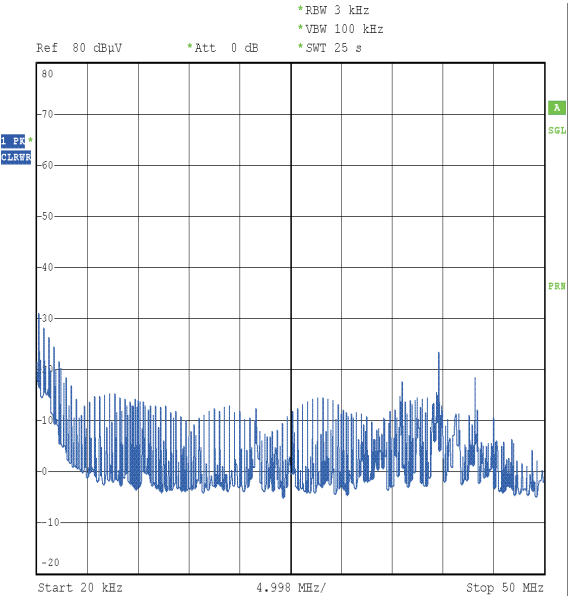
**TYPICAL CHARACTERISTICS (continued)**

**EMISSIONS SPECTRUM TO 10 MHz**



**Figure 23.**

**EMISSIONS SPECTRUM TO 50 MHz**



**Figure 24.**

## APPLICATION INFORMATION

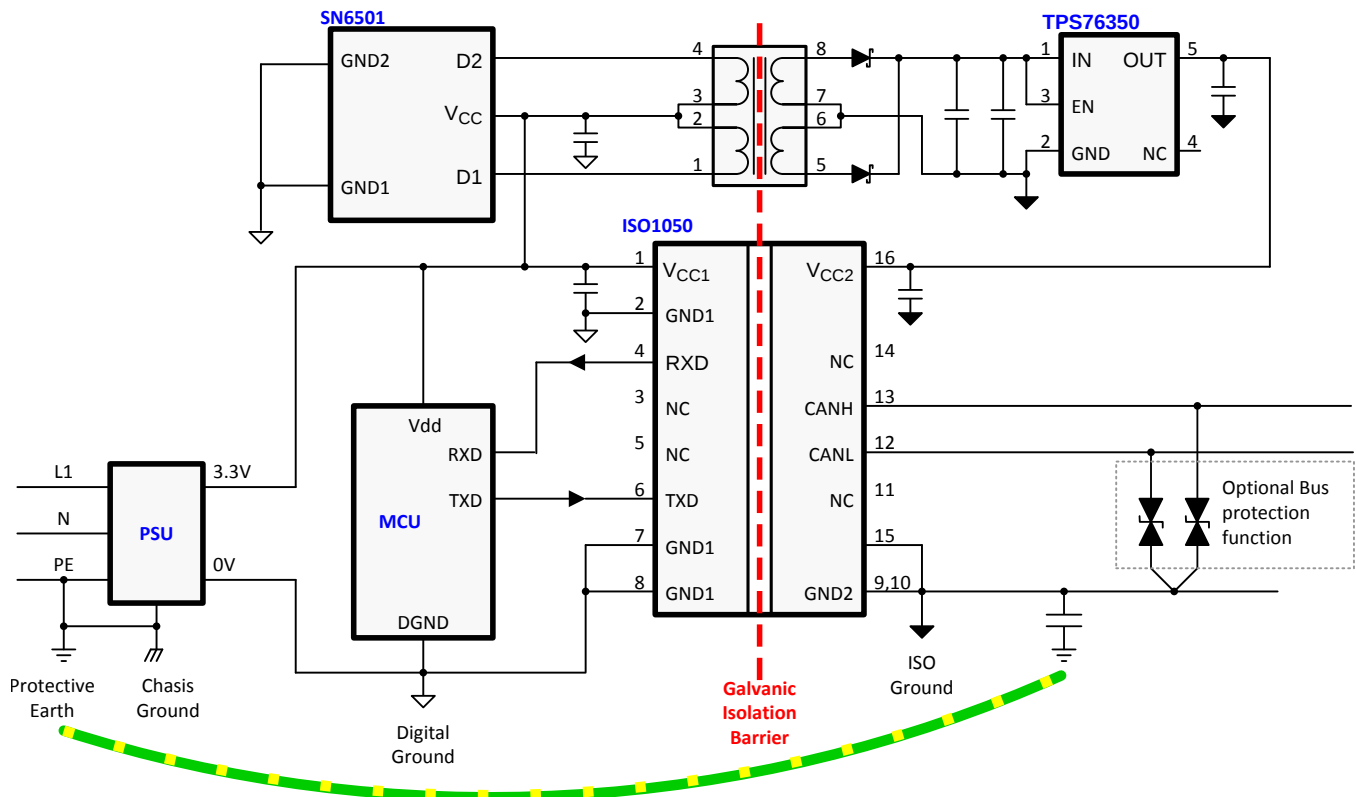


Figure 25. Application Circuit

## BUS LOADING, LENGTH AND NUMBER OF NODES

The ISO11898 Standard specifies a maximum bus length of 40m and maximum stub length of 0.3m with a maximum of 30 nodes. However, with careful design, users can have longer cables, longer stub lengths, and many more nodes to a bus. A high number of nodes requires a transceiver with high input impedance such as the ISO1050.

Many CAN organizations and standards have scaled the use of CAN for applications outside the original ISO11898 standard. They have made system level trade offs for data rate, cable length, and parasitic loading of the bus. Examples of some of these specifications are ARINC825, CANopen, CAN Kingdom, DeviceNet and NMEA200.

A CAN network design is a series of tradeoffs, but these devices operate over wide –12-V to 12-V common-mode range. In ISO11898-2 the driver differential output is specified with a 60Ω load (the two 120Ω termination resistors in parallel) and the differential output must be greater than 1.5V. The ISO1050 is specified to meet the 1.5V requirement with a 60Ω load, and additionally specified with a differential output of 1.4V with a 45Ω load. The differential input resistance of the ISO1050 is a minimum of 30KΩ. If 167 ISO1050 transceivers are in parallel on a bus, this is equivalent to a 180Ω differential load. That transceiver load of 180Ω in parallel with the 60Ω gives a total 45Ω. Therefore, the ISO1050 theoretically supports over 167 transceivers on a single bus segment with margin to the 1.2V minimum differential input at each node. However for CAN network design margin must be given for signal loss across the system and cabling, parasitic loadings, network imbalances, ground offsets and signal integrity thus a practical maximum number of nodes is typically much lower. Bus length may also be extended beyond the original ISO11898 standard of 40m by careful system design and data rate tradeoffs. For example, CANopen network design guidelines allow the network to be up to 1km with changes in the termination resistance, cabling, less than 64 nodes and significantly lowered data rate.

This flexibility in CAN network design is one of the key strengths of the various extensions and additional standards that have been built on the original ISO11898 CAN standard. In using this flexibility comes the responsibility of good network design.

## CAN TERMINATION

The ISO11898 standard specifies the interconnect to be a single twisted pair cable (shielded or unshielded) with 120Ω characteristic impedance ( $Z_0$ ). Resistors equal to the characteristic impedance of the line should be used to terminate both ends of the cable to prevent signal reflections. Unterminated drop-lines (stubs) connecting nodes to the bus should be kept as short as possible to minimize signal reflections. The termination may be in a node, but if nodes may be removed from the bus, the termination must be carefully placed so that it is not removed from the bus.

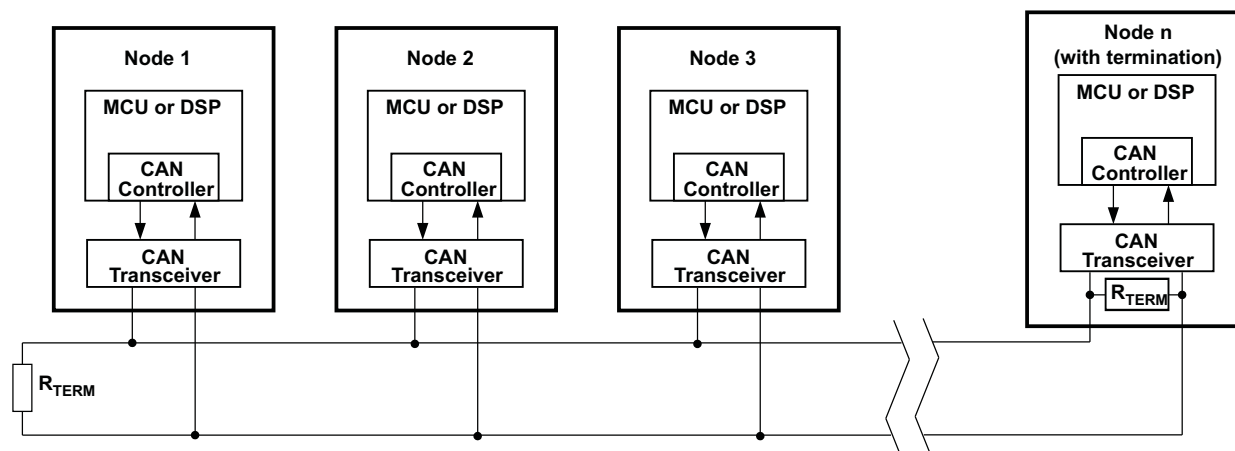


Figure 26. Typical CAN Bus

Termination may be a single 120 Ω resistor at the end of the bus, either on the cable or in a terminating node. If filtering and stabilization of the common mode voltage of the bus is desired, then split termination may be used. (See Figure 27). Split termination improves the electromagnetic emissions behavior of the network by eliminating fluctuations in the bus common-mode voltages at the start and end of message transmissions.

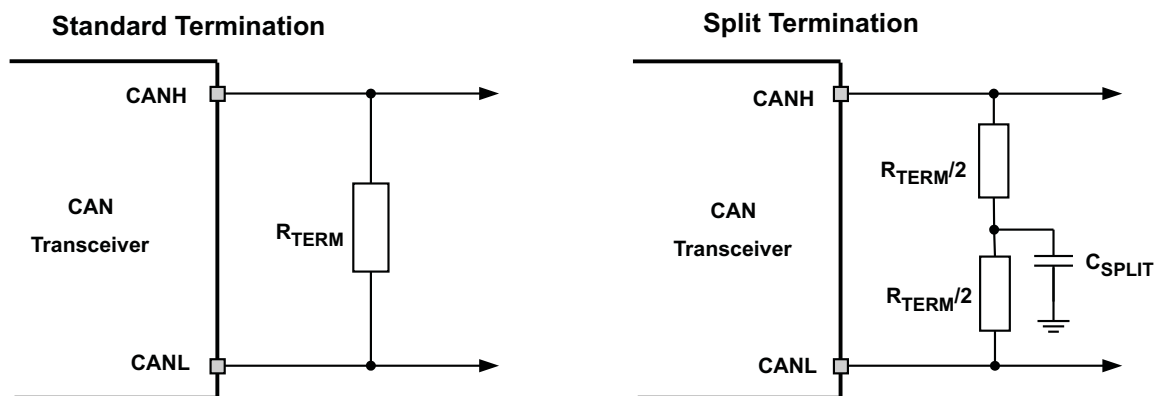


Figure 27. CAN Bus Termination Concepts

## REVISION HISTORY

### Changes from Original (June 2009) to Revision A Page

- Added Typical 25-Year Life at Rated Working Voltage to Features ..... [1](#)
- Added LIFE EXPECTANCY vs WORKING VOLTAGE section ..... [17](#)

### Changes from Revision A (Sept 2009) to Revision B Page

- Added information that IEC 60747-5-2 and IEC61010-1 have been approved ..... [1](#)
- Changed DW package from preview to production data ..... [1](#)
- Added Insulation Characteristics and IEC 60664-1 Ratings tables ..... [15](#)
- Added IEC file number ..... [16](#)
- Added DW-16 thermal information table ..... [17](#)

### Changes from Revision B (June 2009) to Revision C Page

- Changed the IEC 60747-5-2 Features bullet From: DW package Approval Pending To: VDE approved for both DUB and DW packages ..... [1](#)
- Changed the Minimum Internal Gap value from 0.008 to 0.014 in the Isolator Characteristics table ..... [15](#)
- Changed  $V_{IORM}$  Specification From: 1300 To: 1200 per VDE certification ..... [15](#)
- Changed  $V_{PR}$  Specification From 2438 To: 2250 ..... [15](#)
- Added the Bus Loading paragraph to the Application Information section ..... [21](#)

### Changes from Revision C (July 2010) to Revision D Page

- Changed the SUPPLY CURRENT table for  $I_{CC1}$  1st row From: Typ = 1 To: 1.8 and MAX = 2 To: 2.8 ..... [7](#)
- Changed the SUPPLY CURRENT table for  $I_{CC1}$  2nd row From: Typ = 2 To: 2.8 and MAX = 3 To: 3.6 ..... [7](#)
- Changed the REGULATORY INFORMATION table ..... [16](#)

**Changes from Revision D (June 2011) to Revision E****Page**

|                                                                                                                            |    |
|----------------------------------------------------------------------------------------------------------------------------|----|
| • Added device ISO1050L .....                                                                                              | 1  |
| • Changed (DW Package) in the Features list to (ISO1050DW) .....                                                           | 1  |
| • Changed (DUB Package) in the Features list to (ISO1050DUB and ISO1050LDW) .....                                          | 1  |
| • Deleted IEC 60950-1 from the CSA Approvals Feature bullet .....                                                          | 1  |
| • From: IEC 60601-1 (Medical) and CSA Approvals Pending To: IEC 60601-1 (Medical) and CSA Approved .....                   | 1  |
| • Added Feature - 5 KVRMS Reinforced.. .....                                                                               | 1  |
| • Changed DW Package to ISO1050DW and DUB package to ISO1050DUB and ISO1050LDW in the first paragraph of DESCRIPTION ..... | 1  |
| • Added the AVAILABLE OPTIONS table .....                                                                                  | 2  |
| • Added Note 1 to the INSULATION CHARACTERISTICS table .....                                                               | 15 |
| • Changed $V_{IORM}$ From: 8-DUB Package to ISO1050DUB and ISO1050LDW .....                                                | 15 |
| • Changed $V_{IORM}$ From: 16-DW to ISO1050DW .....                                                                        | 15 |
| • Changed the $V_{ISO}$ Isolation voltage per UL section of the INSULATION CHARACTERISTICS table. ....                     | 15 |
| • Changed the IEC 60664-1 Ratings Table .....                                                                              | 15 |
| • Changed the REGULATORY INFORMATION table .....                                                                           | 16 |
| • Changed From: File Number: 220991 (Approval Pending) To: File Number: 220991 .....                                       | 16 |
| • Changed in note (1) 3000 to 2500 and 6000 to 5000 .....                                                                  | 16 |
| • Changed in LIFE EXPECTANCY vs WORKING VOLTAGE (8-DUB PACKAGE TO: LIFE.....(ISO1050DW and ISO1050LDW) .....               | 17 |

**Changes from Revision E (December 2011) to Revision F****Page**

|                                                                                                                |    |
|----------------------------------------------------------------------------------------------------------------|----|
| • Deleted ISO1050L device .....                                                                                | 1  |
| • Deleted ISO1050LDW from Features list .....                                                                  | 1  |
| • Deleted ISO1050LDW in first paragraph of DESCRIPTION .....                                                   | 1  |
| • Deleted ISO1050LDW from AVAILABLE OPTIONS .....                                                              | 2  |
| • Added the PIN FUNCTIONS section .....                                                                        | 2  |
| • Added the FUNCTIONAL DESCRIPTION section .....                                                               | 3  |
| • Added Note 1 to the DRIVER SWITCHING CHARACTERISTICS table .....                                             | 8  |
| • Deleted ISO1050LDW from INSULATION CHARACTERISTICS .....                                                     | 15 |
| • Deleted ISO1050LDW from REGULATORY INFORMATION .....                                                         | 16 |
| • Deleted ISO1050LDW from LIFE EXPECTANCY vs WORKING VOLTAGE .....                                             | 17 |
| • Deleted 40V from the CANH and CANL input diagrams and output diagrams in the EQUIVALENT I/O SCHEMATICS ..... | 18 |
| • Changed the APPLICATION INFORMATION section .....                                                            | 21 |

**PACKAGING INFORMATION**

| Orderable Device | Status<br>(1) | Package Type | Package<br>Drawing | Pins | Package Qty | Eco Plan<br>(2)            | Lead/Ball Finish | MSL Peak Temp<br>(3) | Samples<br>(Requires Login) |
|------------------|---------------|--------------|--------------------|------|-------------|----------------------------|------------------|----------------------|-----------------------------|
| ISO1050DUB       | ACTIVE        | SOP          | DUB                | 8    | 50          | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-4-260C-72 HR   |                             |
| ISO1050DUBR      | ACTIVE        | SOP          | DUB                | 8    | 350         | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-4-260C-72 HR   |                             |
| ISO1050DW        | ACTIVE        | SOIC         | DW                 | 16   | 40          | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-2-260C-1 YEAR  |                             |
| ISO1050DWR       | ACTIVE        | SOIC         | DW                 | 16   | 2000        | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-2-260C-1 YEAR  |                             |

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBsolete:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

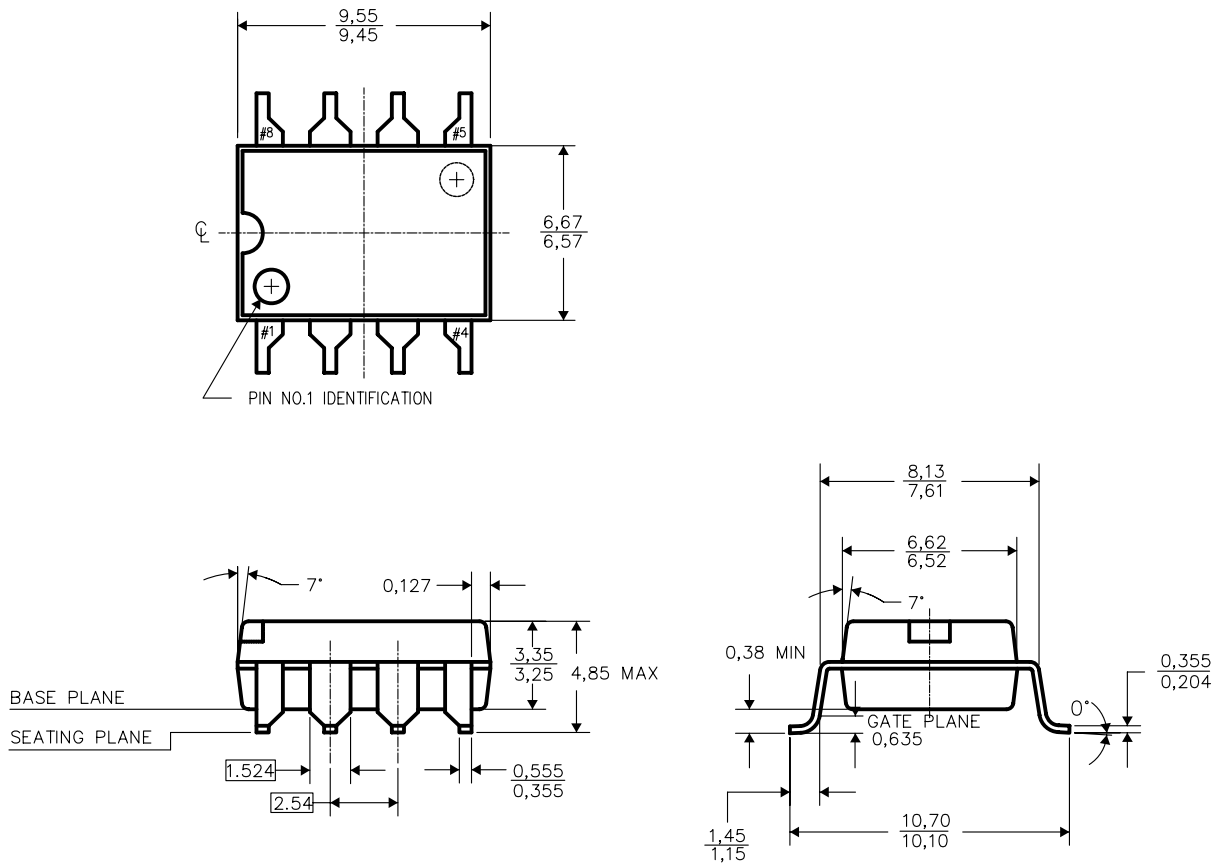
(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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## DUB (R-PDSO-G8)

## PLASTIC SMALL-OUTLINE

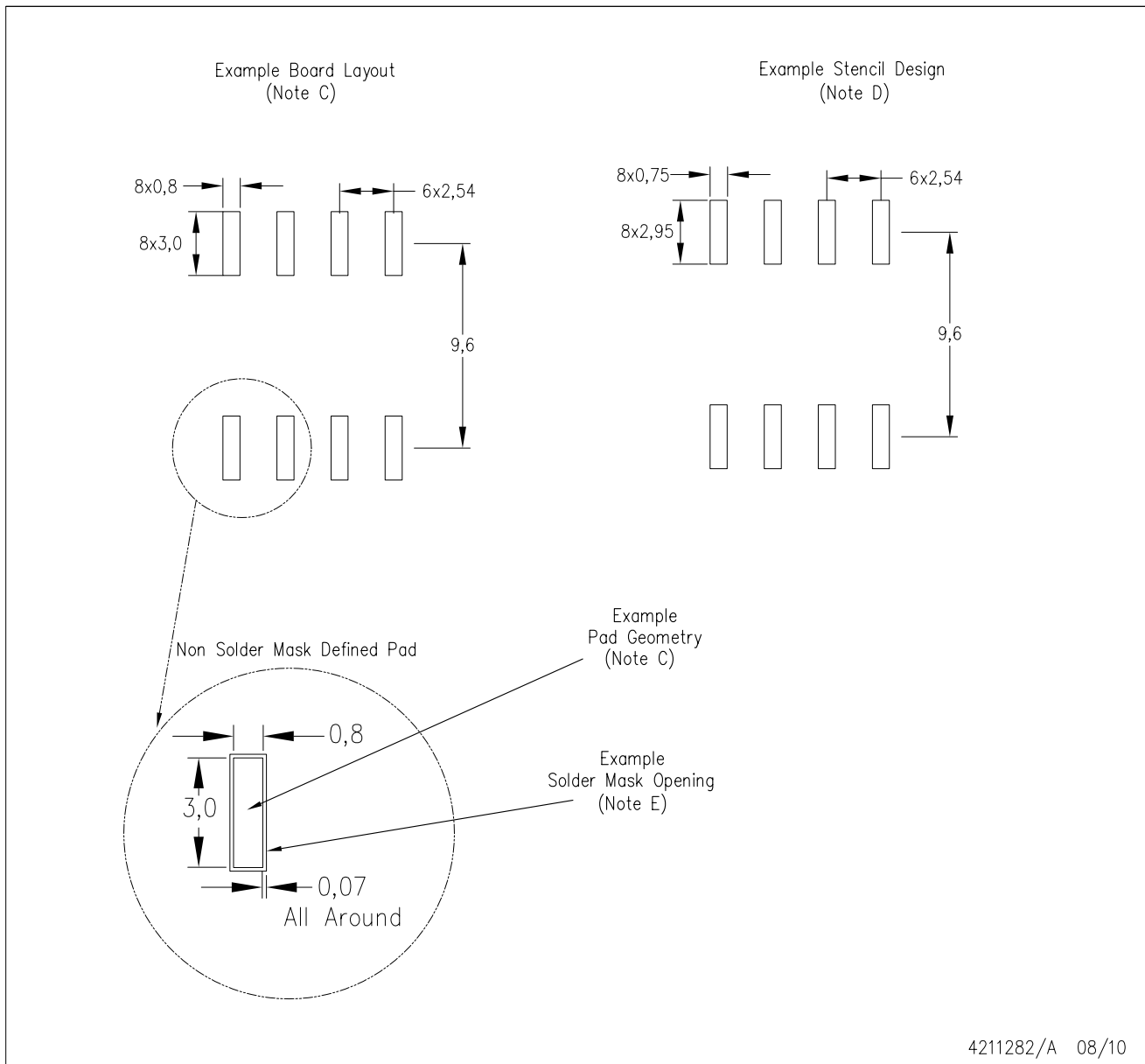


4207614/C 05/06

- NOTES:
- All linear dimensions are in millimeters. Dimensioning and tolerancing per ANSI Y14.5 M-1982.
  - This drawing is subject to change without notice.
  - Dimensions do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.254mm.

DUB (R-PDSO-G8)

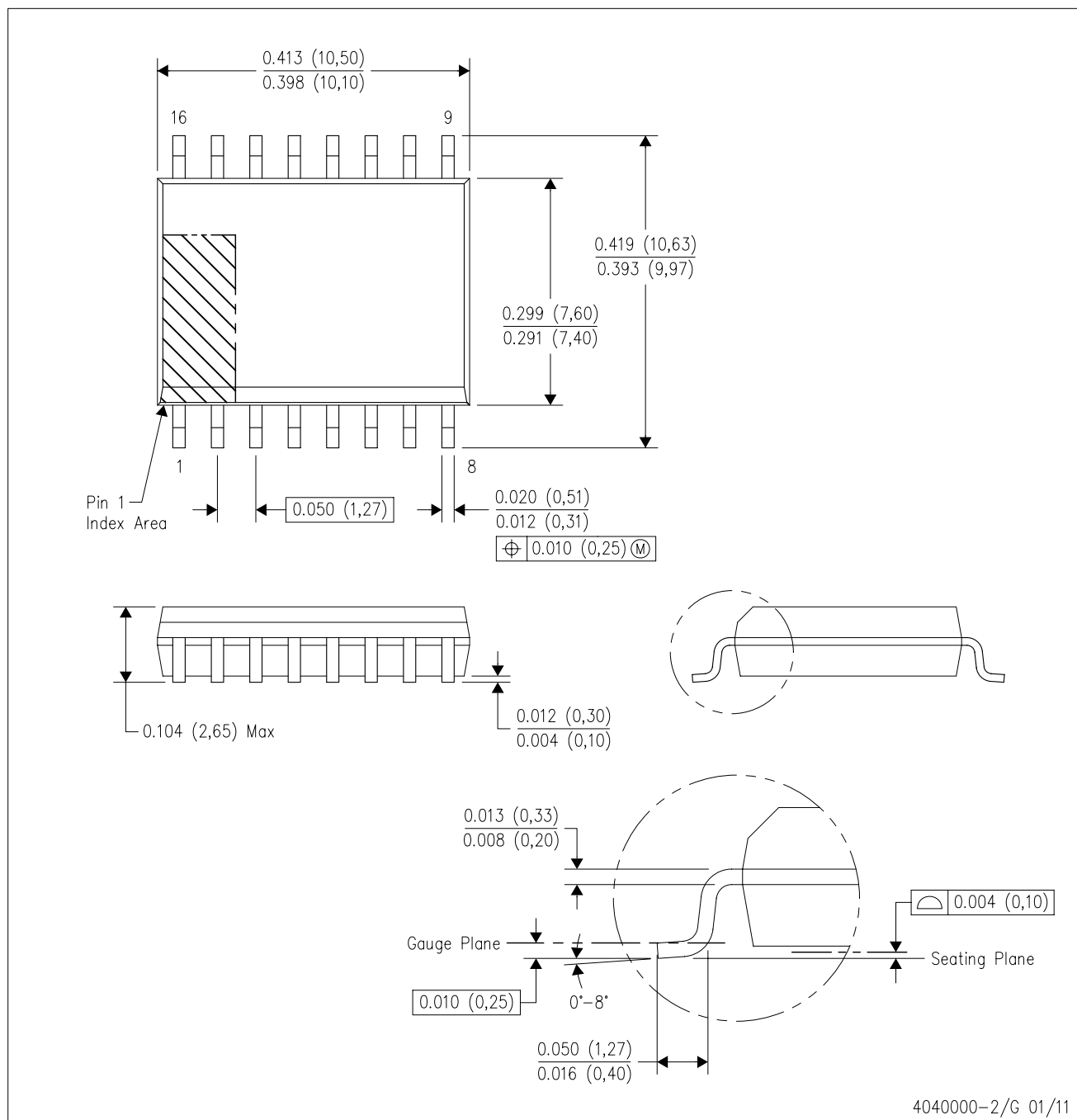
PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Publication IPC-7351 is recommended for alternate designs.
  - D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525.
  - E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

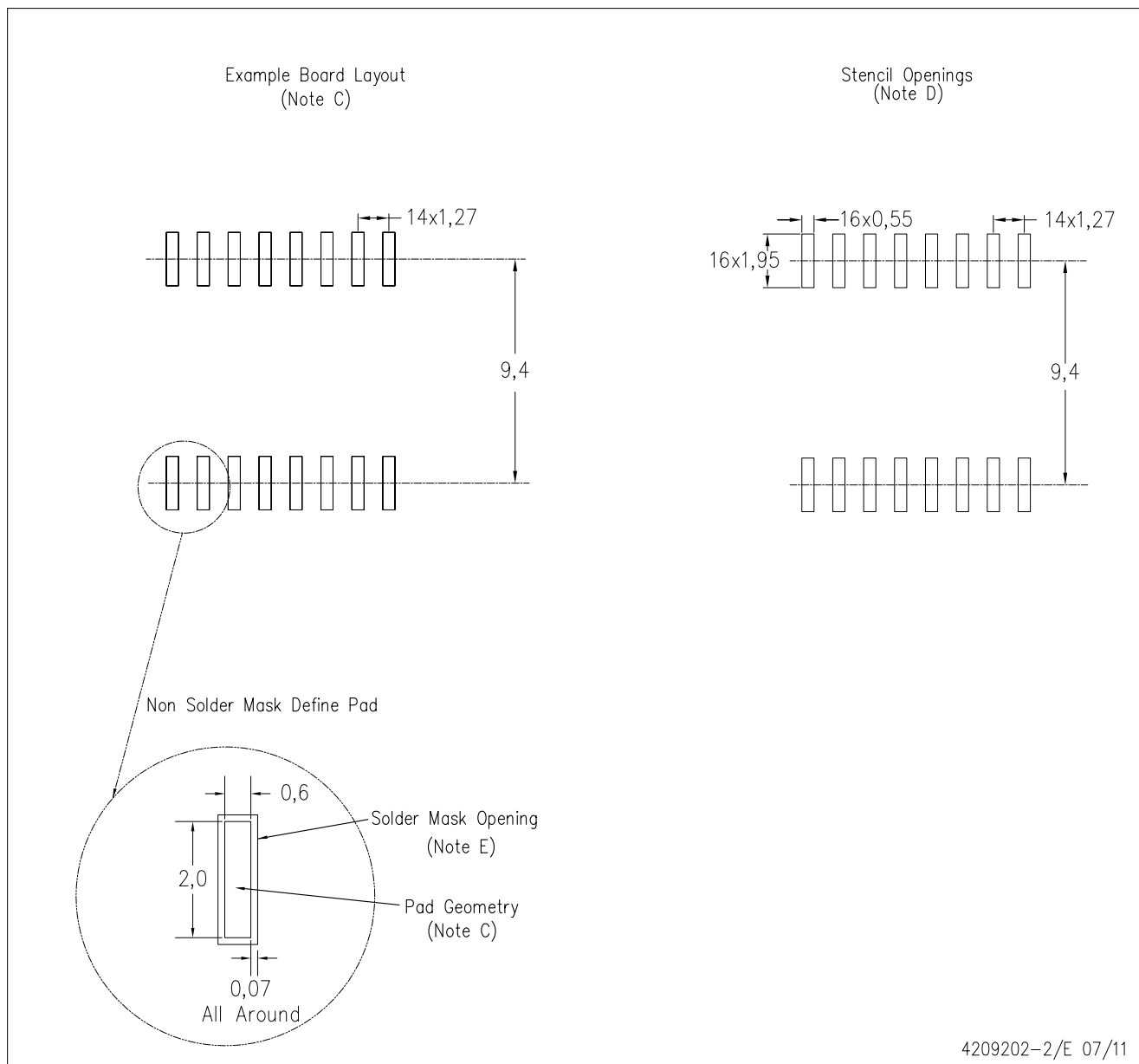
DW (R-PDSO-G16)

PLASTIC SMALL OUTLINE



DW (R-PDSO-G16)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Refer to IPC7351 for alternate board design.
  - D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525
  - E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

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